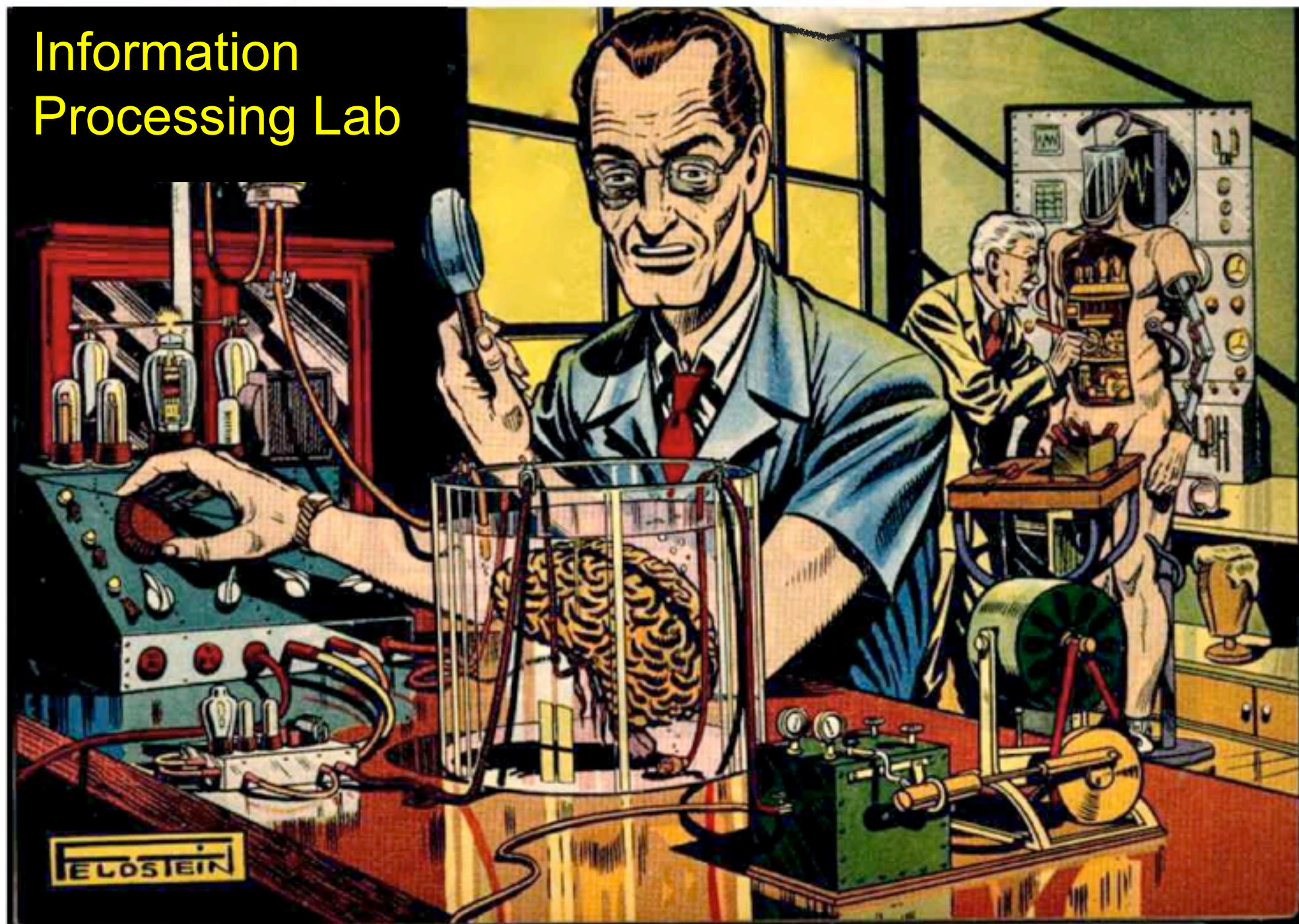


Sequential Analysis in High-Dimensional Multiple Testing and Sparse Recovery

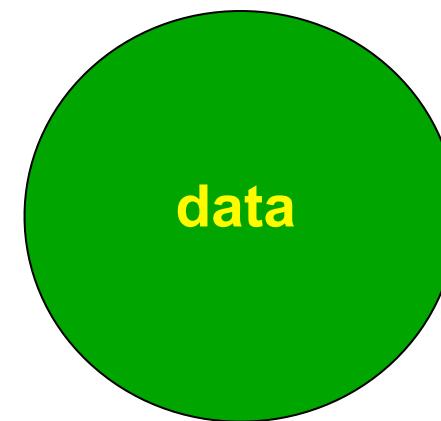
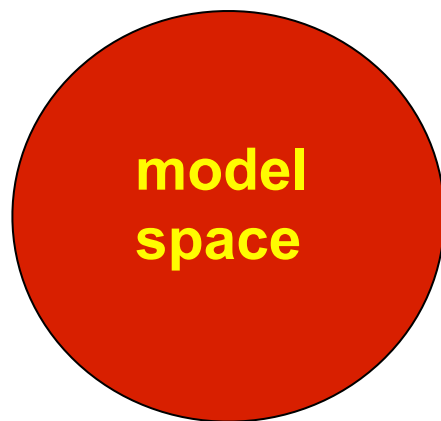


Duke SAHD Workshop, July 27, 2011

Rob Nowak www.ece.wisc.edu/~nowak
joint work with R. Castro, J. Haupt, & M. Malloy

Sequential Sensing and Experimental Design

\mathcal{Y} : possible measurements/experiments

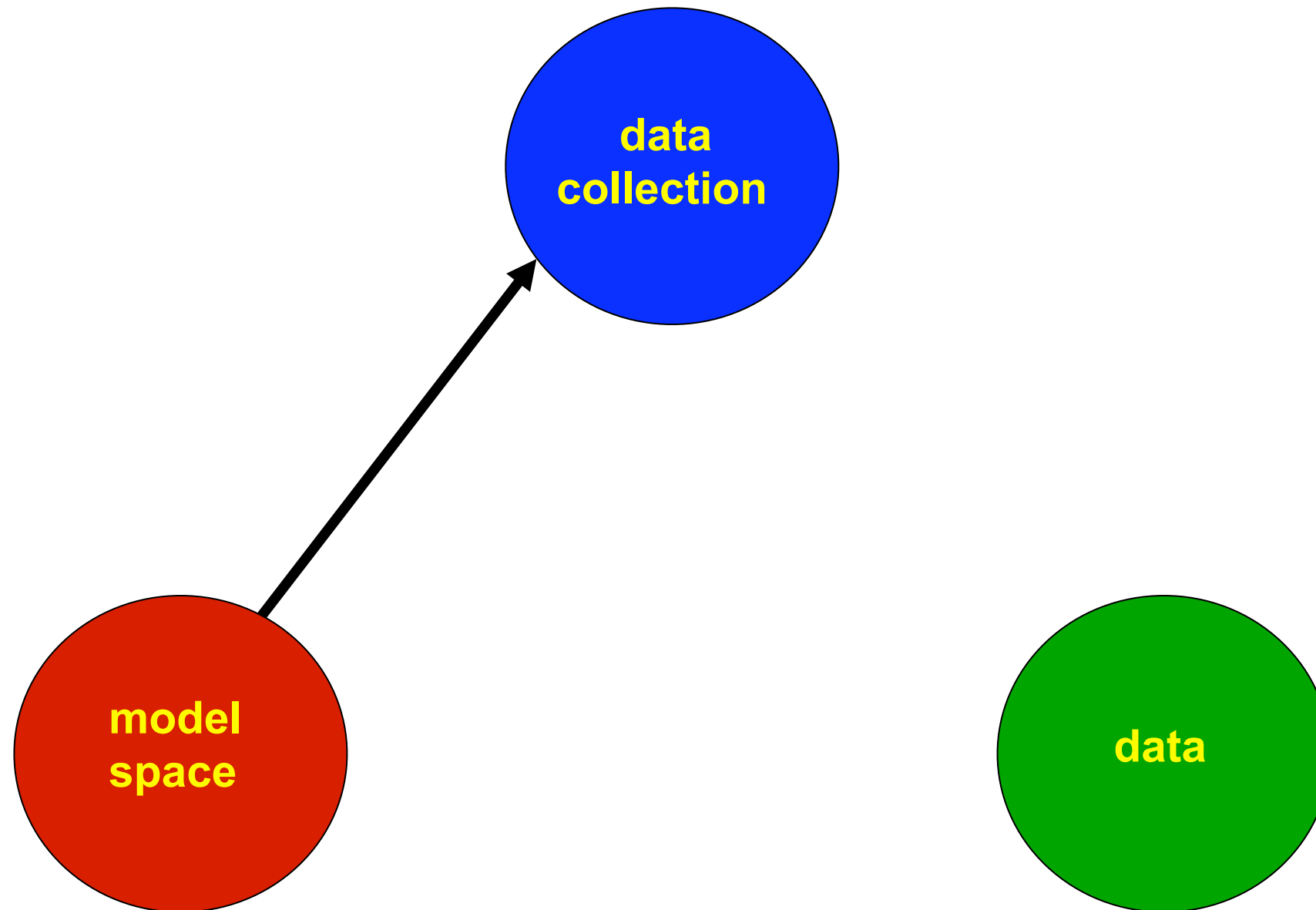


\mathcal{X} : models/hypotheses
under consideration

$y_1(x), y_2(x), \dots$: information/data

Sequential Sensing and Experimental Design

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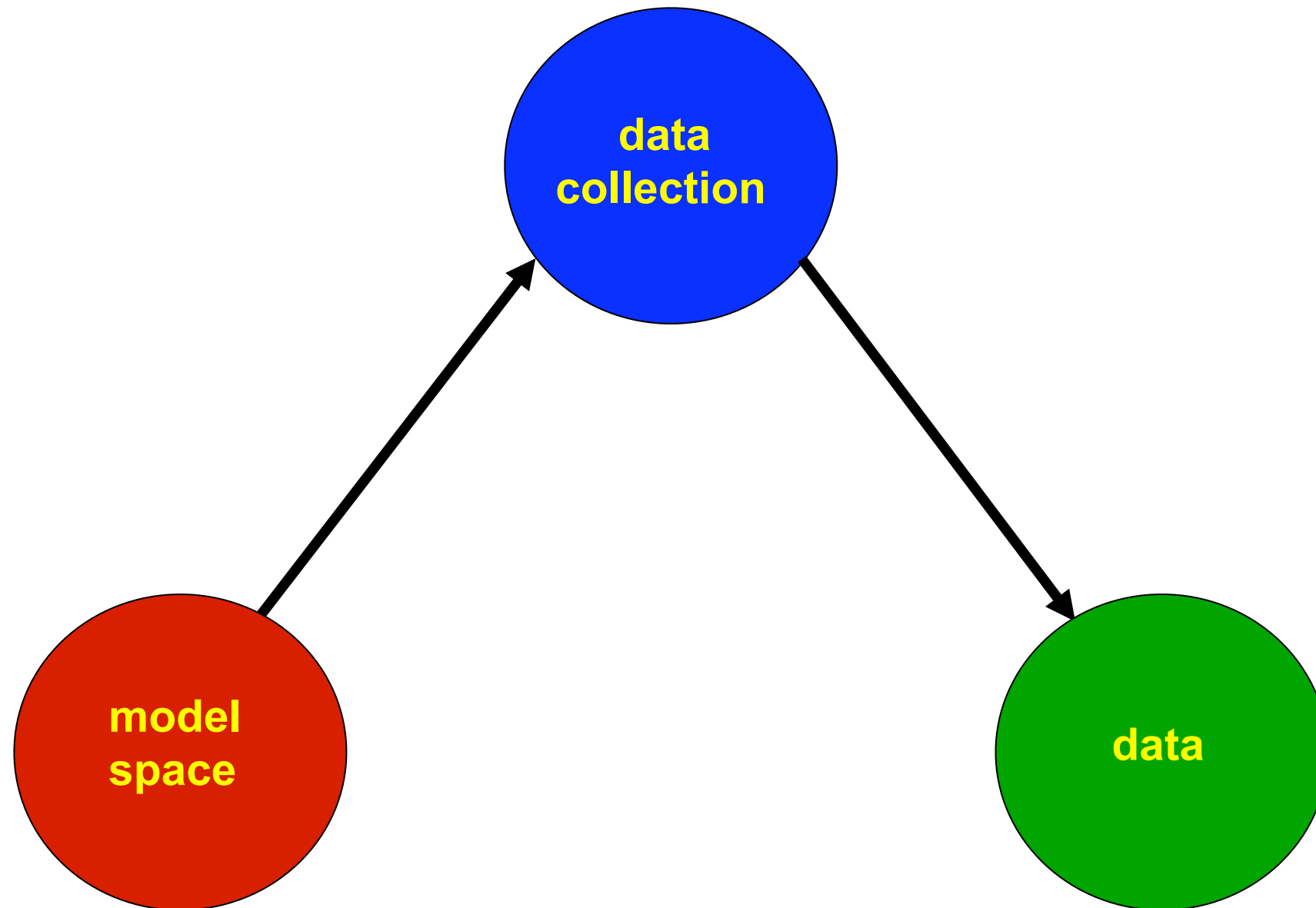


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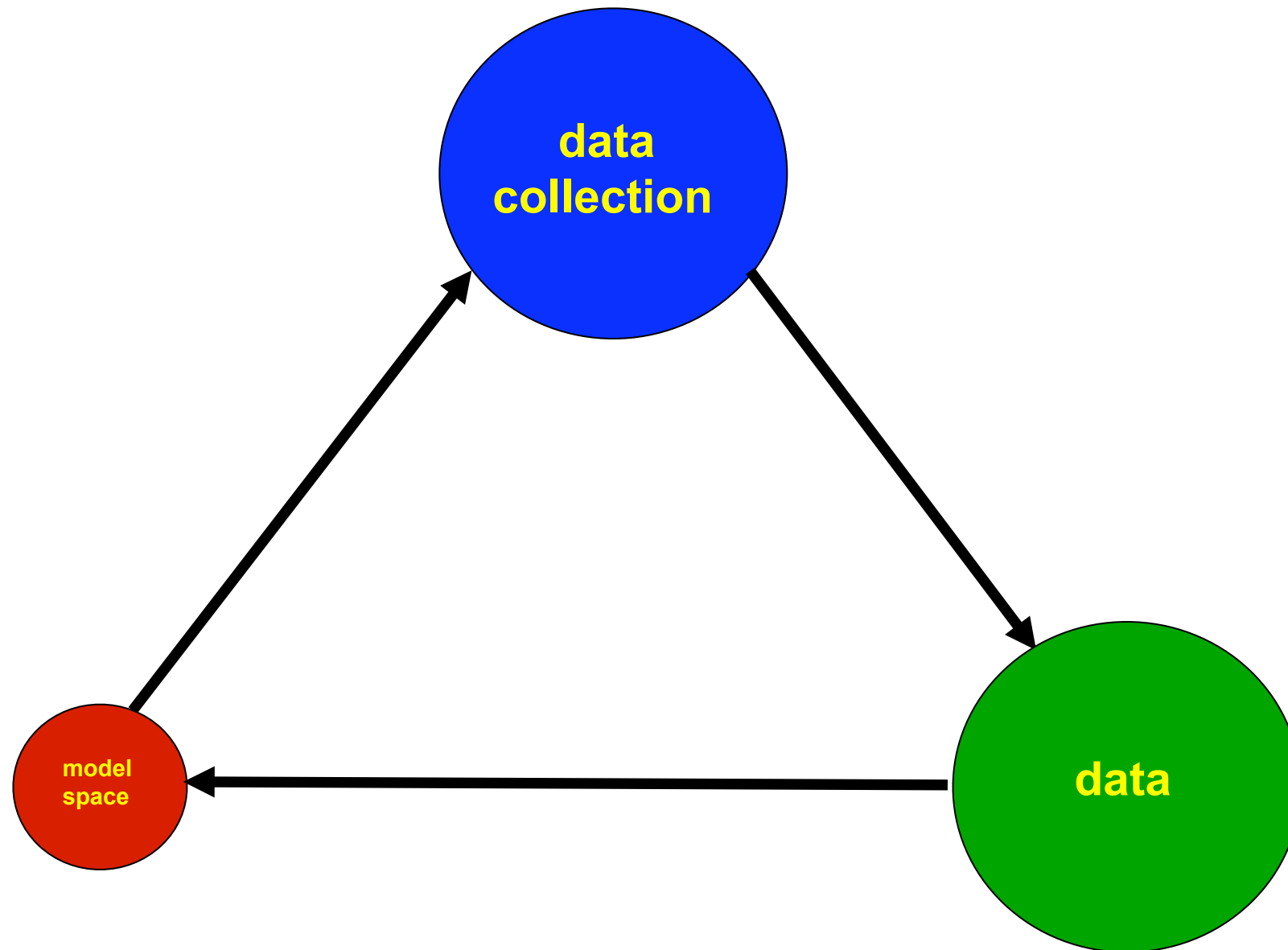


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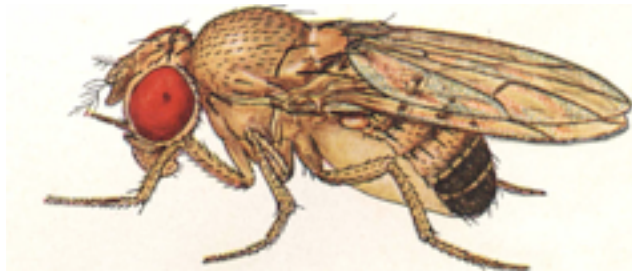
Motivation: Inferring Biological Networks



Paul Alhquist
(Molecular Virology)

Motivation: Inferring Biological Networks

virus



fruit fly



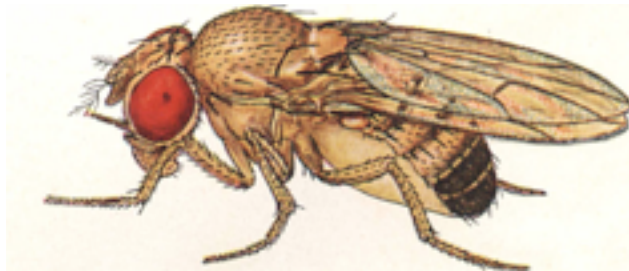
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virus



13,071 single-gene
knock-down cell strains



fruit fly



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virus



13,071 single-gene
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infect each strain
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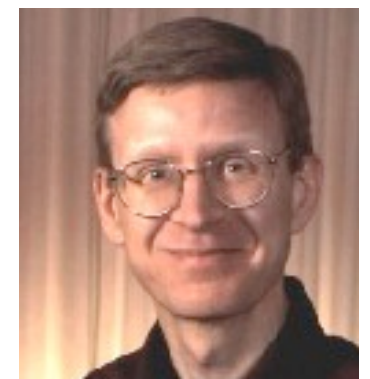


microwell
array



fruit fly

Motivation: Inferring Biological Networks

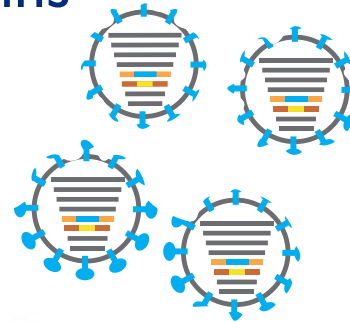


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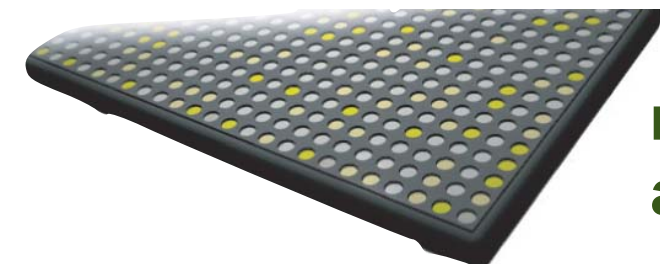
virus



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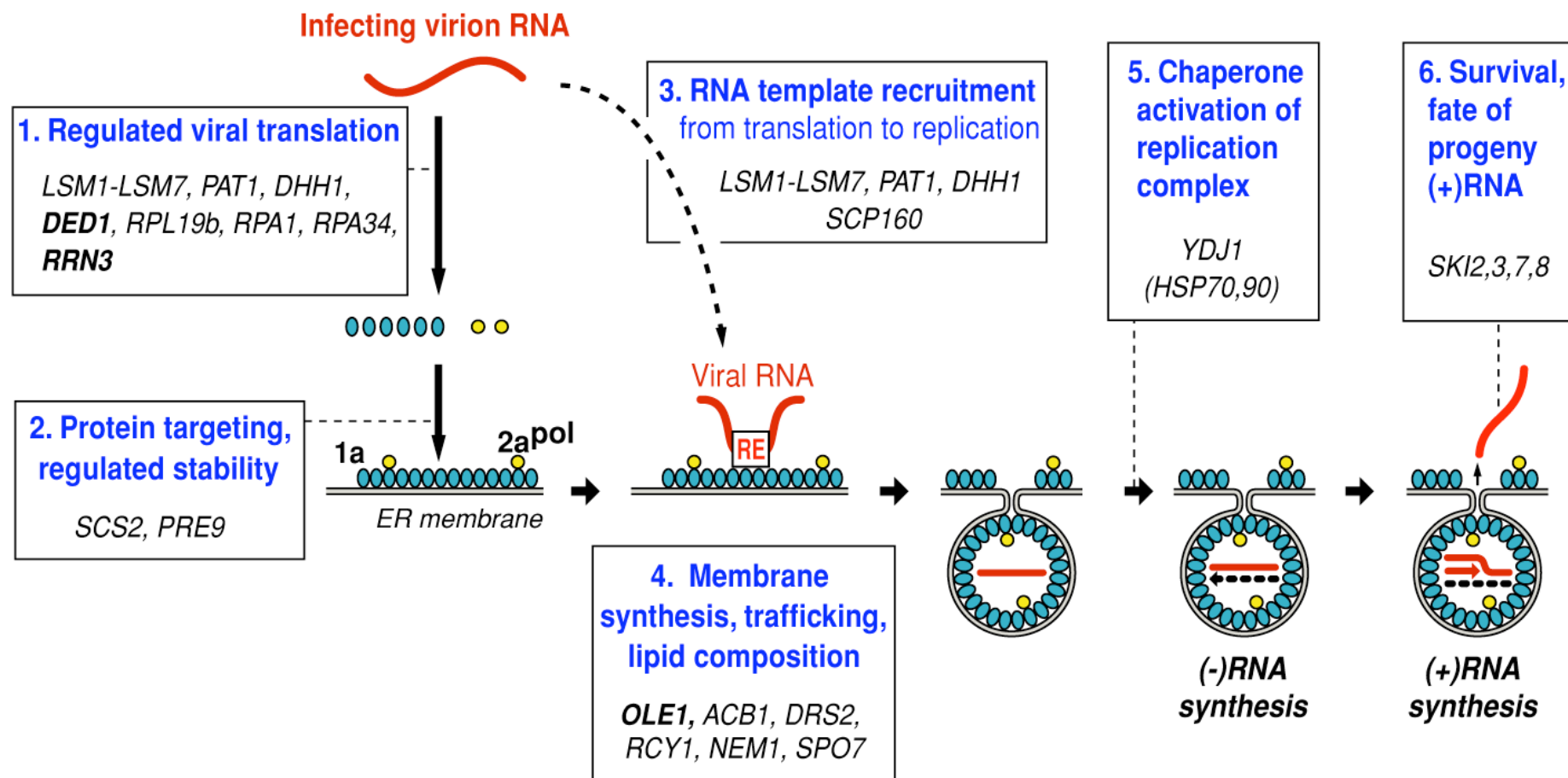


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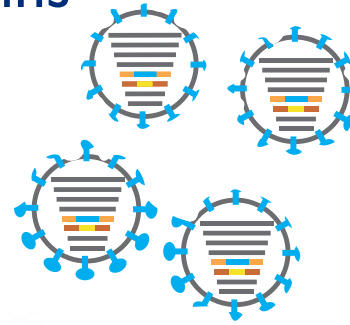


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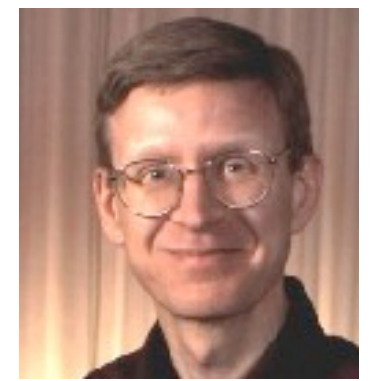
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fruit fly

First question: Who are the players in the network?

“Drosophila RNAi screen identifies host genes important for influenza virus replication,” Nature 2008. How do they confidently determine the ~100 out of 13K genes hijacked for virus replication from extremely noisy data?

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virus



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Sequential Experimental Design:

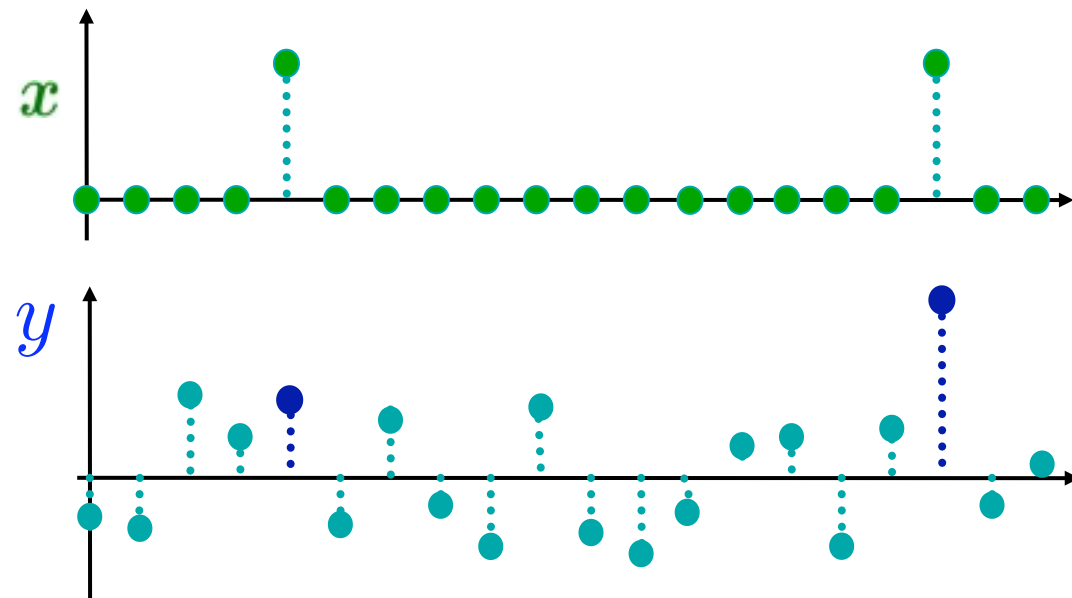
Stage 1: assay all 13K strains, twice; keep all with significant fluorescence in one or both assays for 2nd stage (13K → 1K)

Stage 2: assay remaining 1K strains, 6-12 times; retain only those with statistically significant fluorescence (1K → 100)

vastly more efficient than replicating all 13K experiments many times

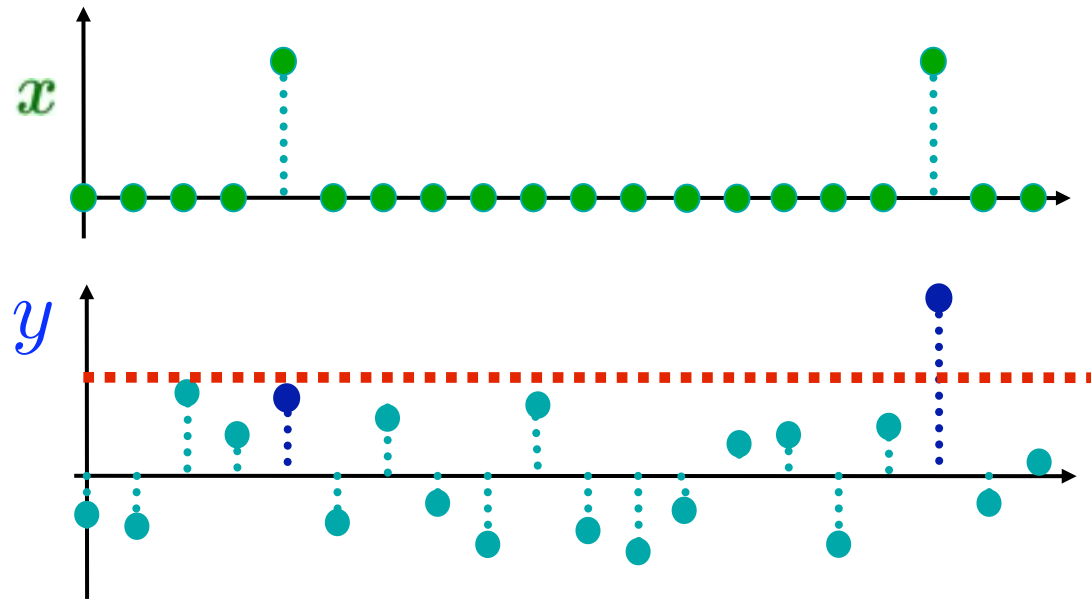
Idealized Example

non-sequential design
(n cell strains, 3 samples each)



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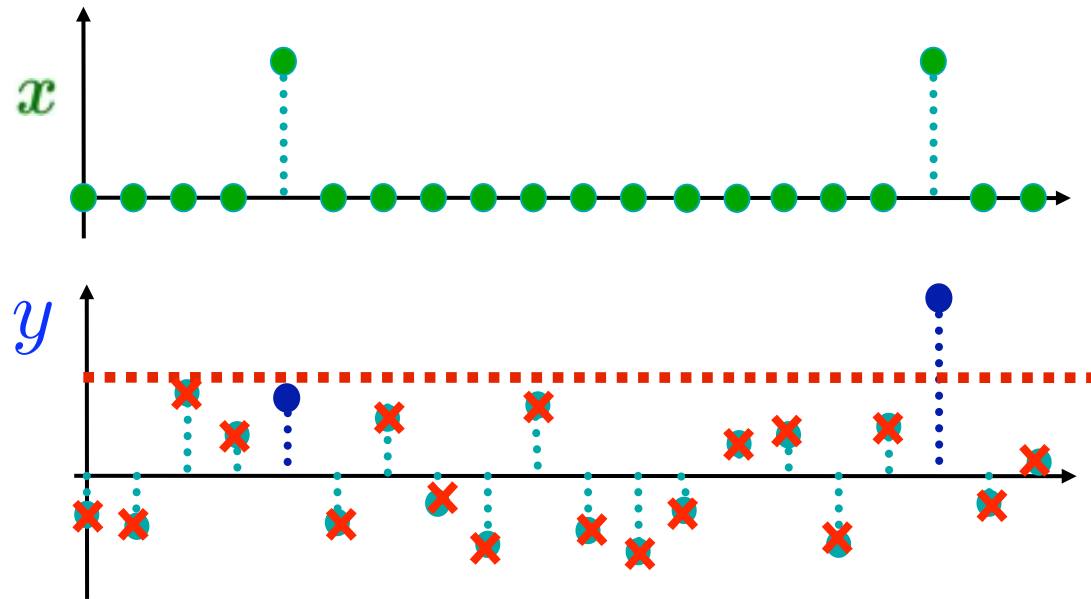
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measure each cell strain with equal
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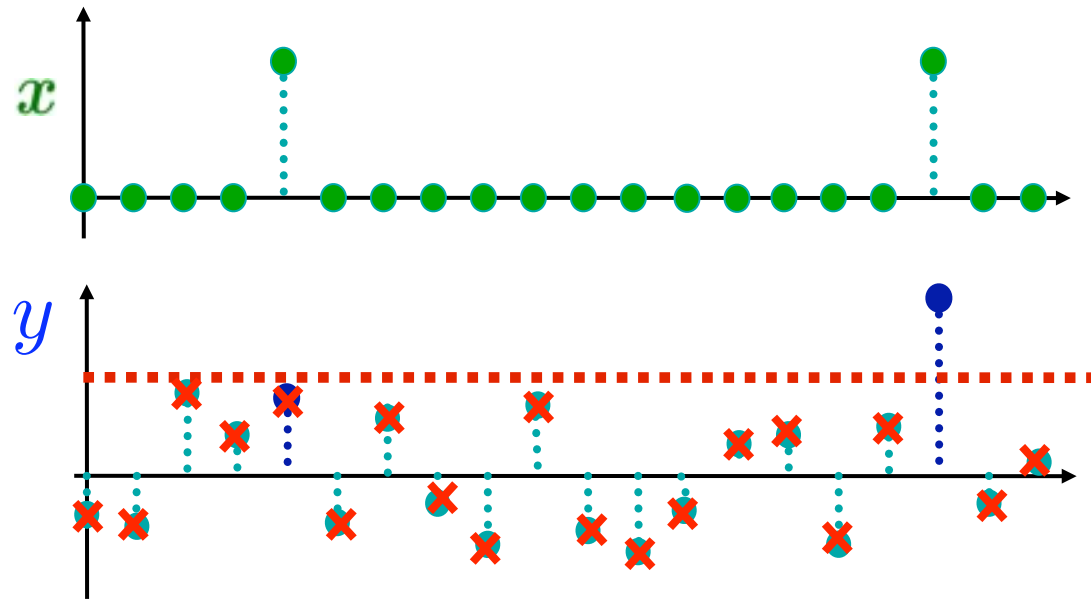
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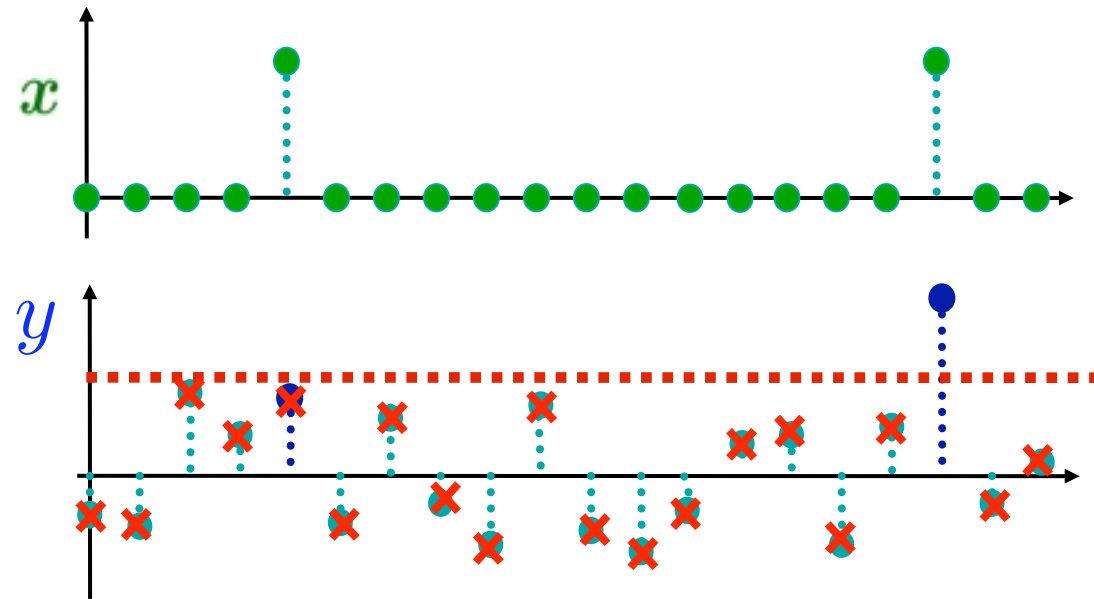


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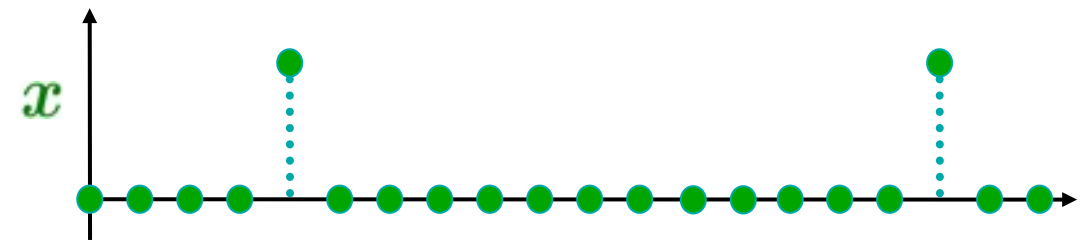
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two-stage design
(adaptively allocate $3n$ samples)

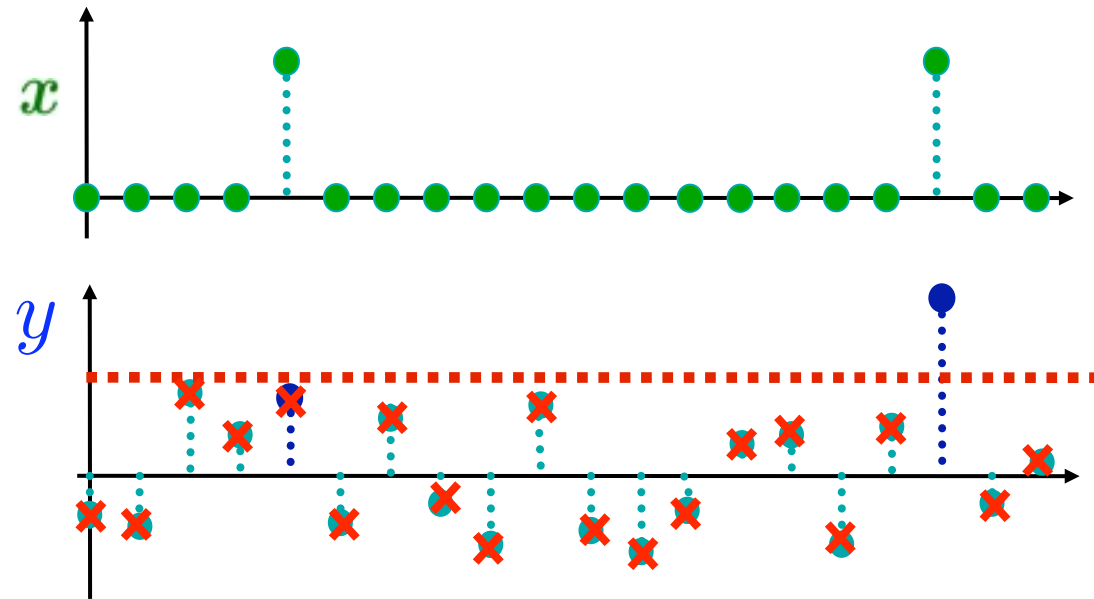


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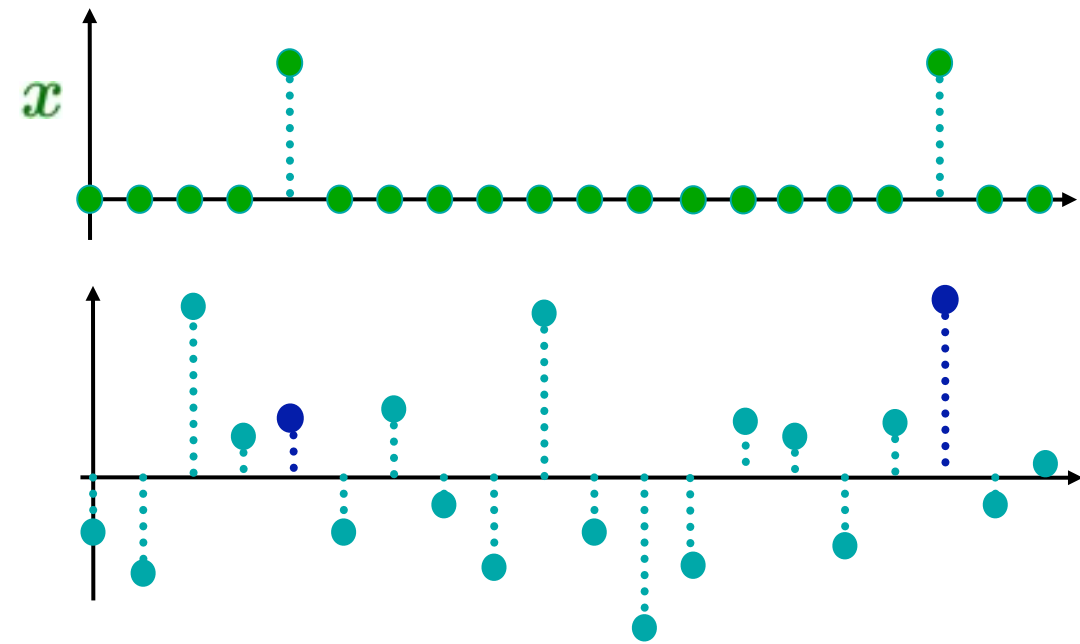
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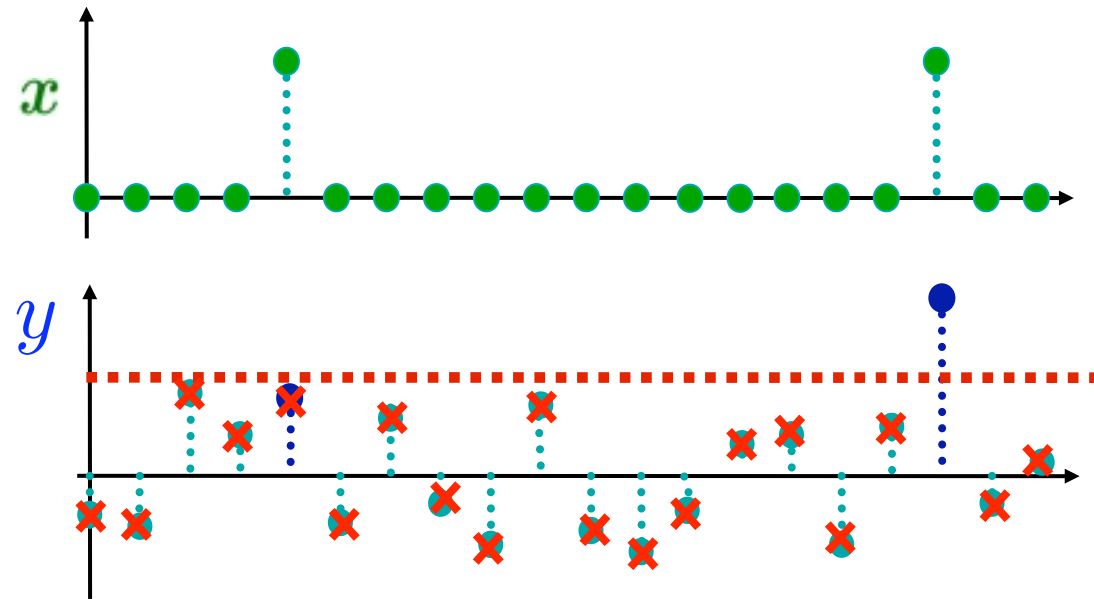


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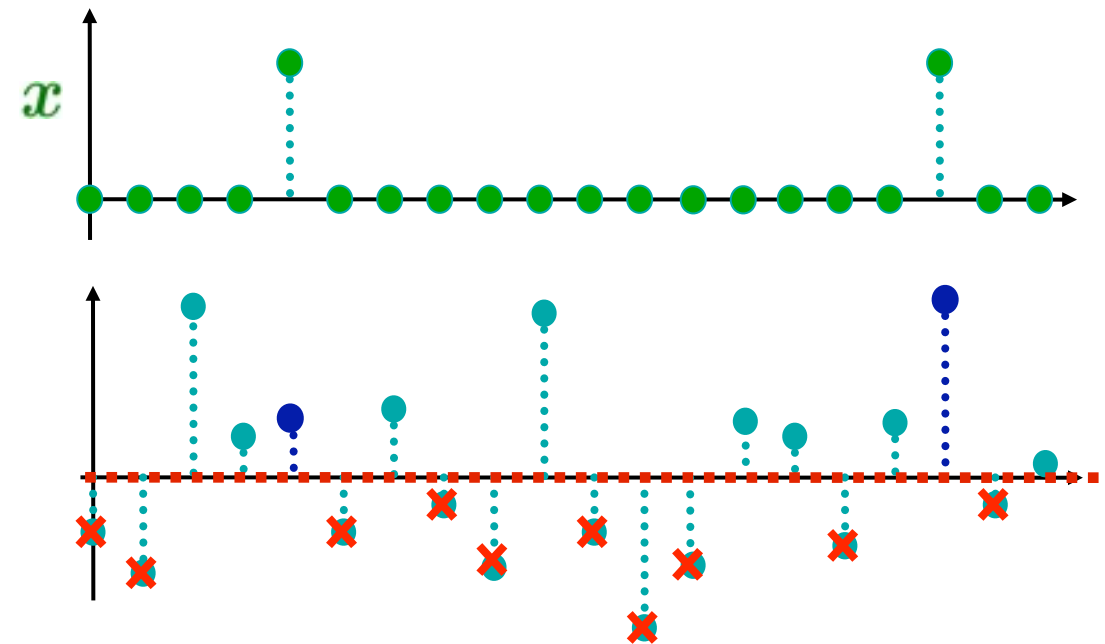
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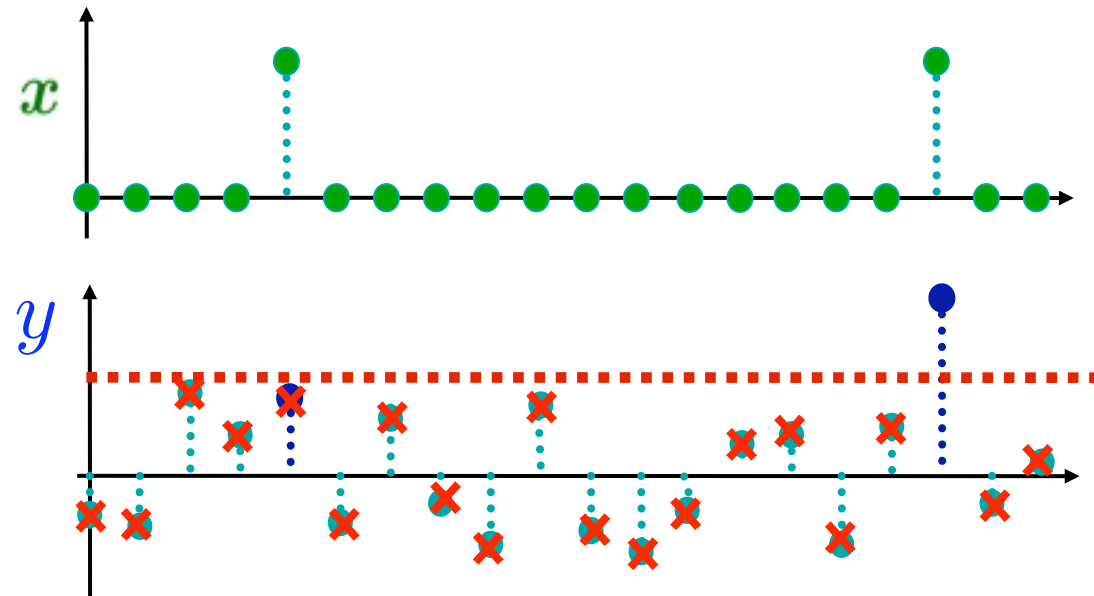


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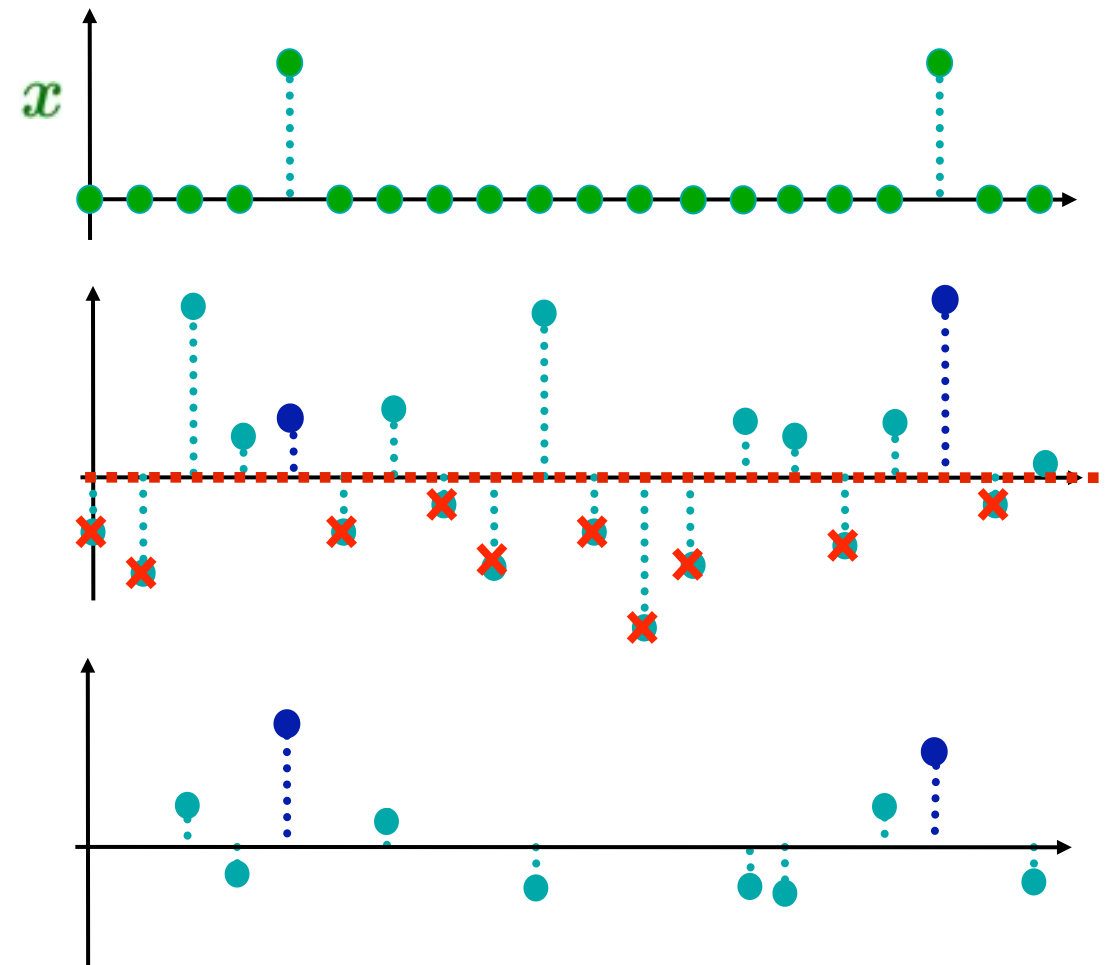
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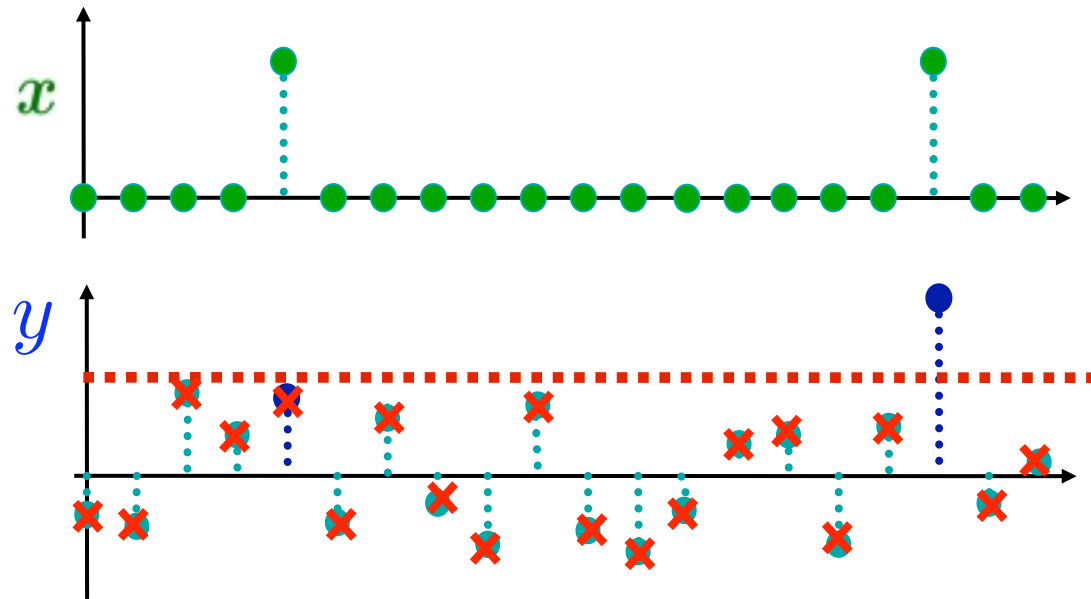
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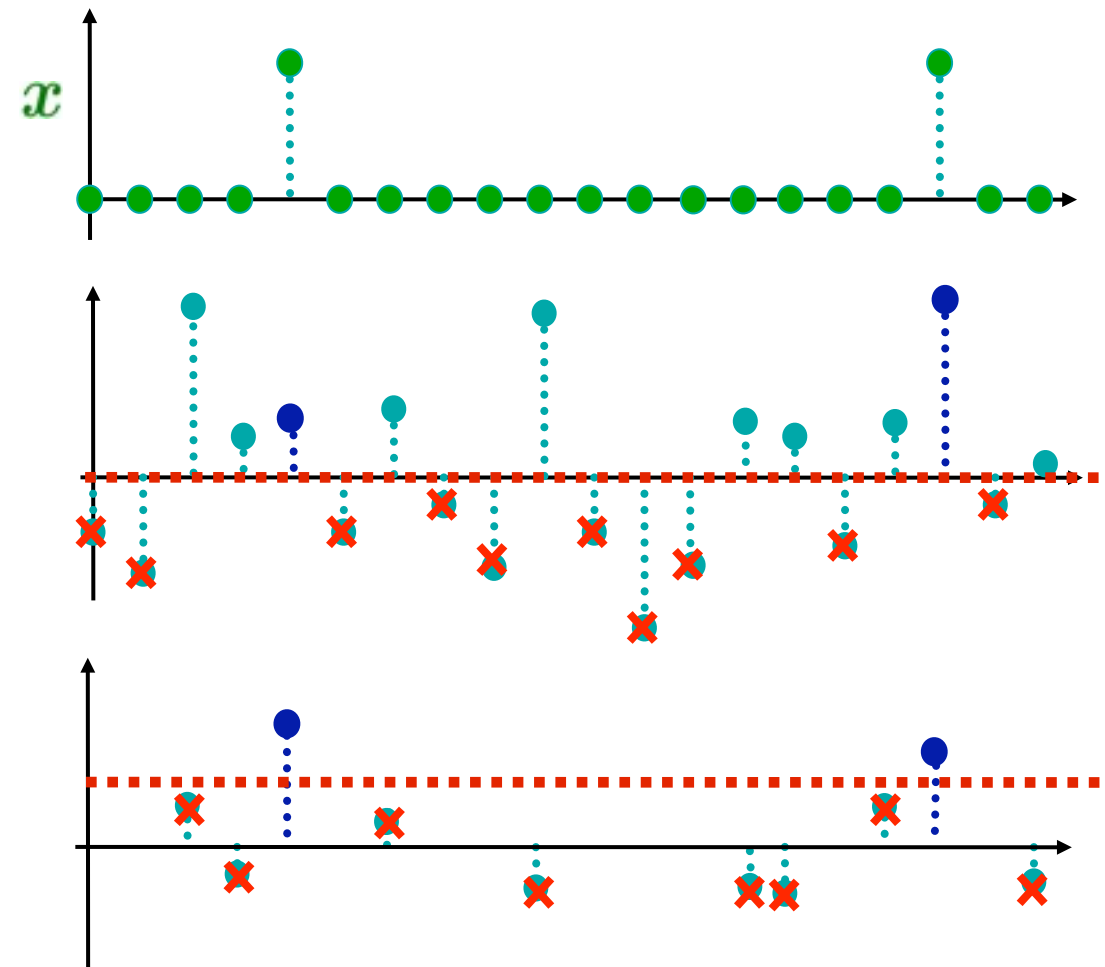
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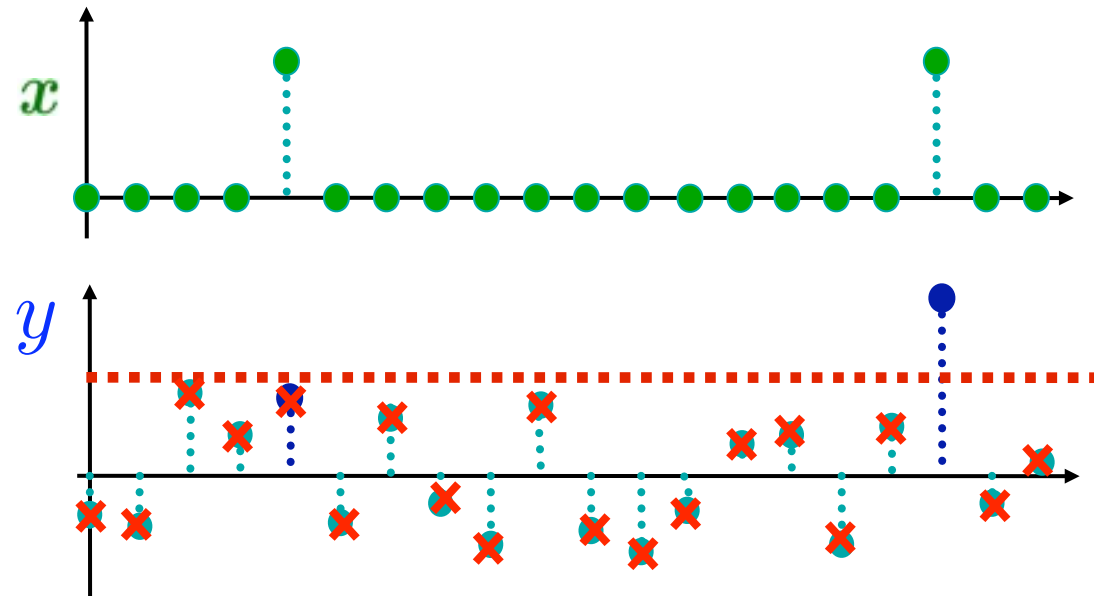
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first stage has large false-positive rate, but low false-negative. larger SNR in second stage makes it easier to separate signals from noise.

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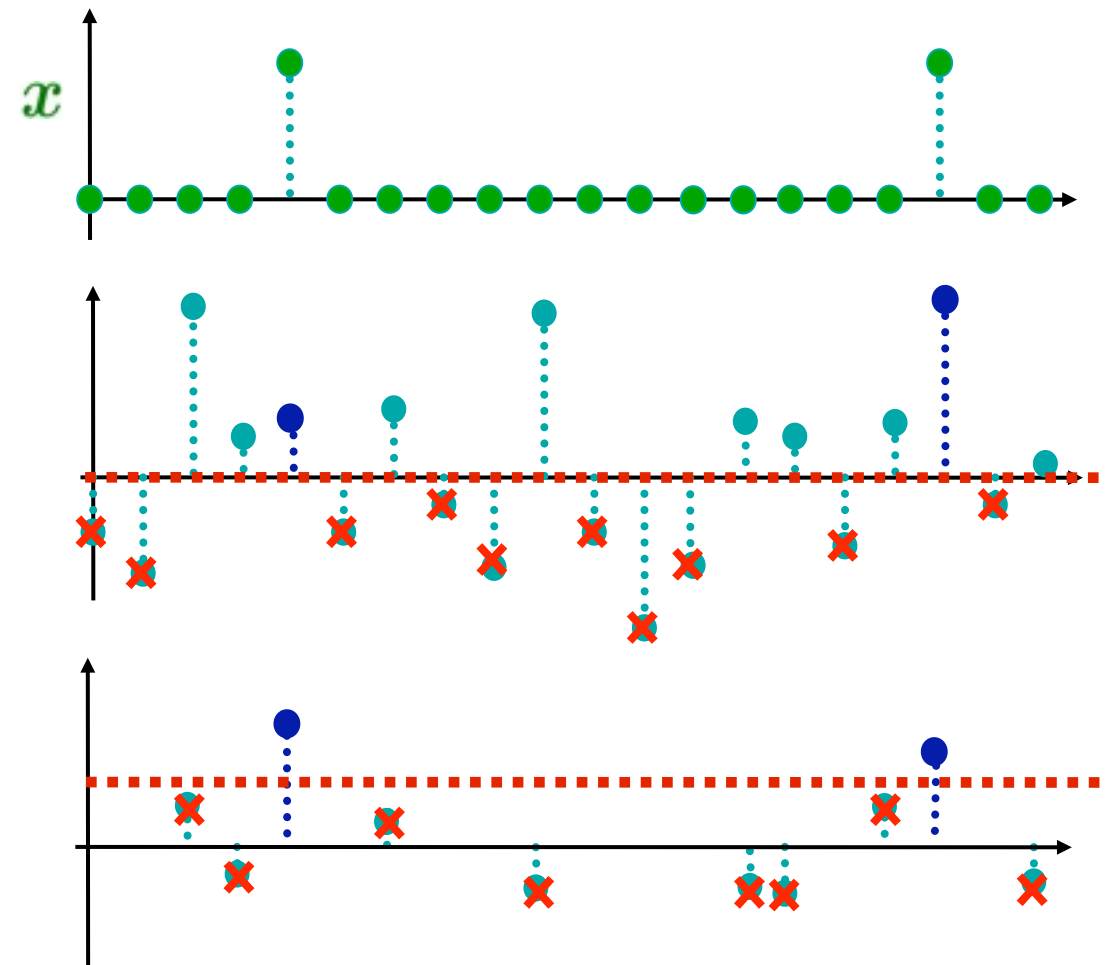
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Under a fixed sensing/experimental budget, does this two-stage design (or some other sequential design) provide better error control than non-sequential design?

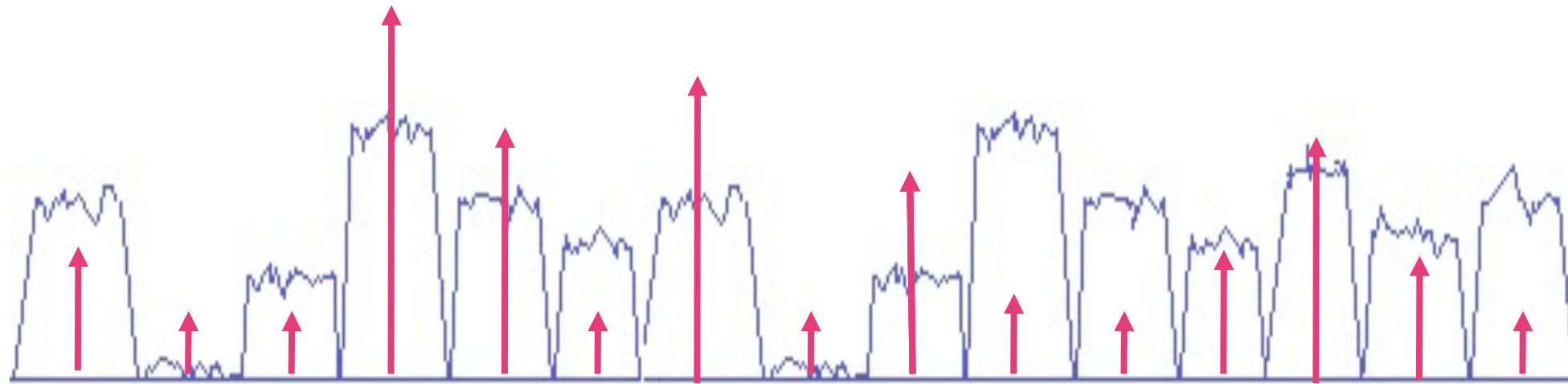
Cognitive Radio Spectrum Sensing

“primary” users have preference over “secondary” users



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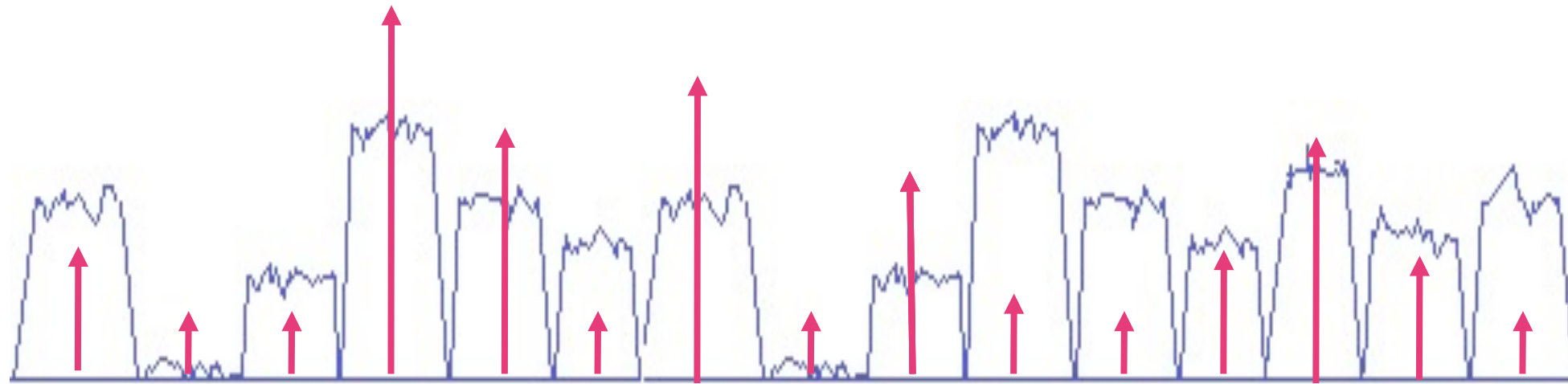
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most channels occupied by primary users, but they come and go in unpredictable manner. Secondary users “sense” spectrum to find an unoccupied channel

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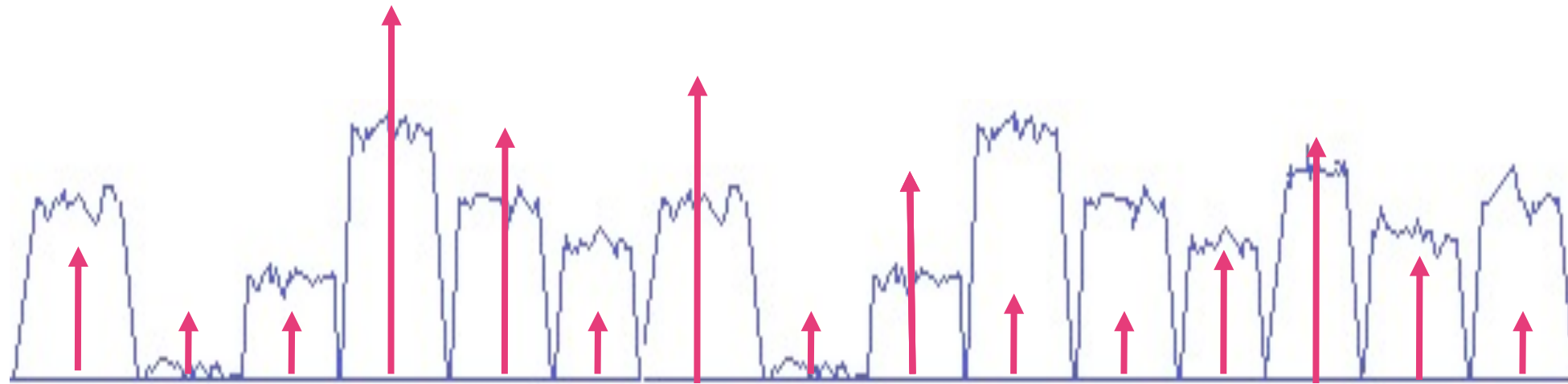
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Goal: Find open channel(s) as quickly as possible. Two approaches:

- 1) listen to each channel for a fixed amount of time and make decision
- 2) listen to each channel for a **data-adaptive** amount of time to make decisions as quickly as possible

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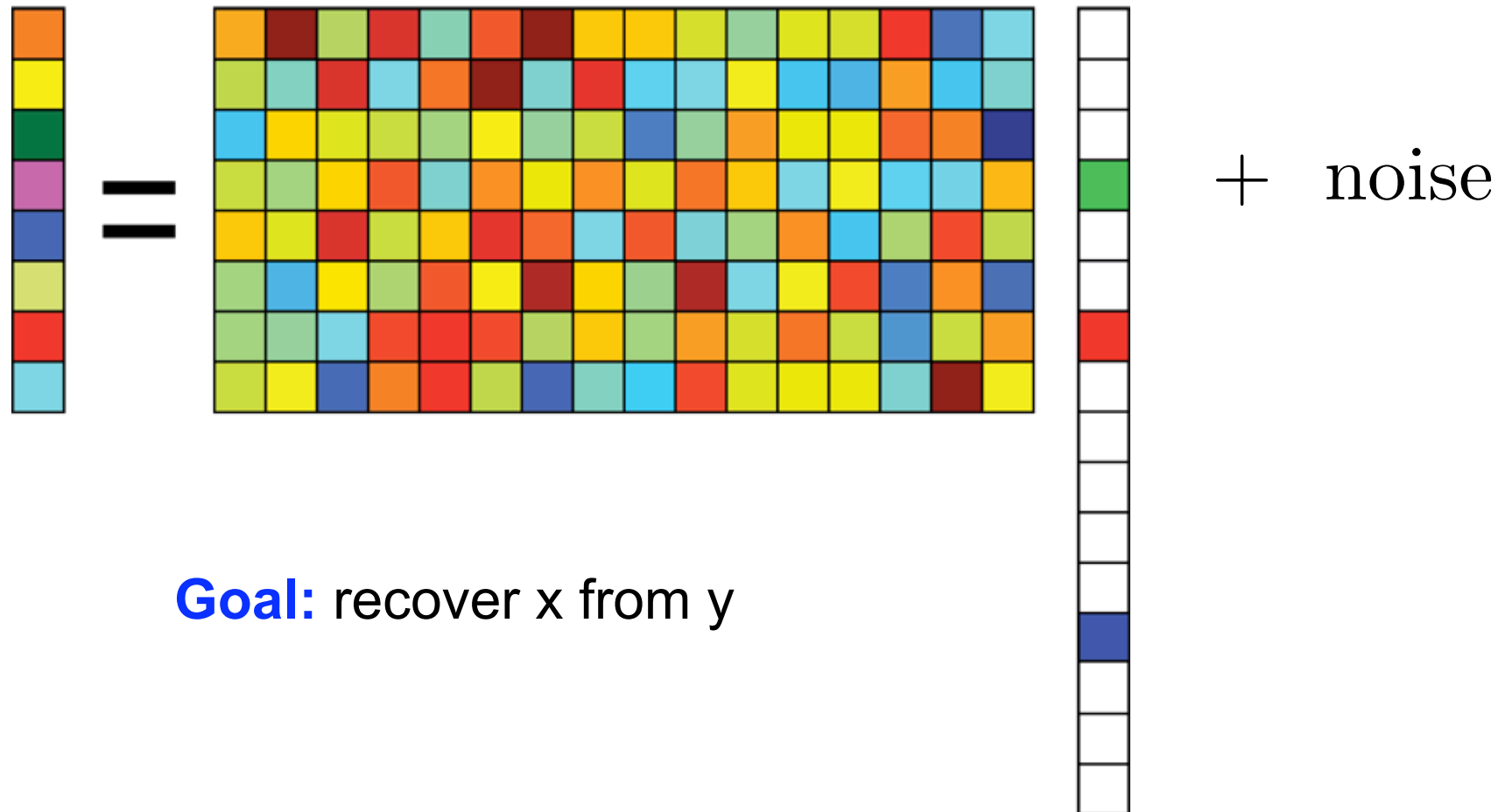
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adaptive spectrum sensing can be significantly more time-efficient than fixed sensing

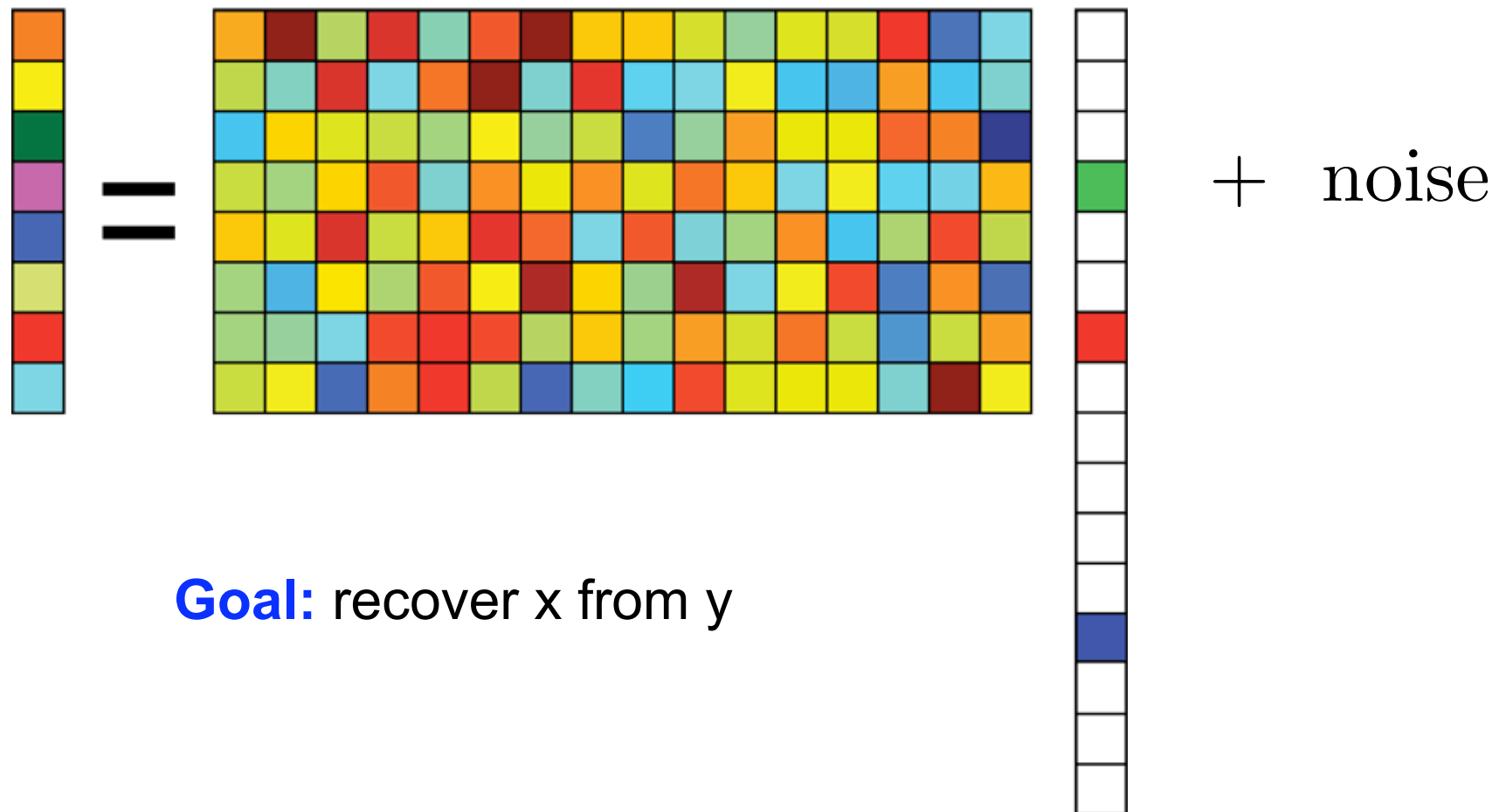
Sparse Recovery (image reconstruction, compressed sensing, inverse problems)

$$y = Ax + w, \text{ with } A \in \mathbb{R}^{m \times n}, x \in \mathbb{R}^n \text{ (but sparse)}, w \sim \mathcal{N}(0, I)$$



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Is sequentially designing (rows of) A advantageous ?

Model Selection

Challenge: huge number of possible models,
each with a different pattern of sparsity

Model Selection

[Wired Science](#)

[News for Your Neurons](#)

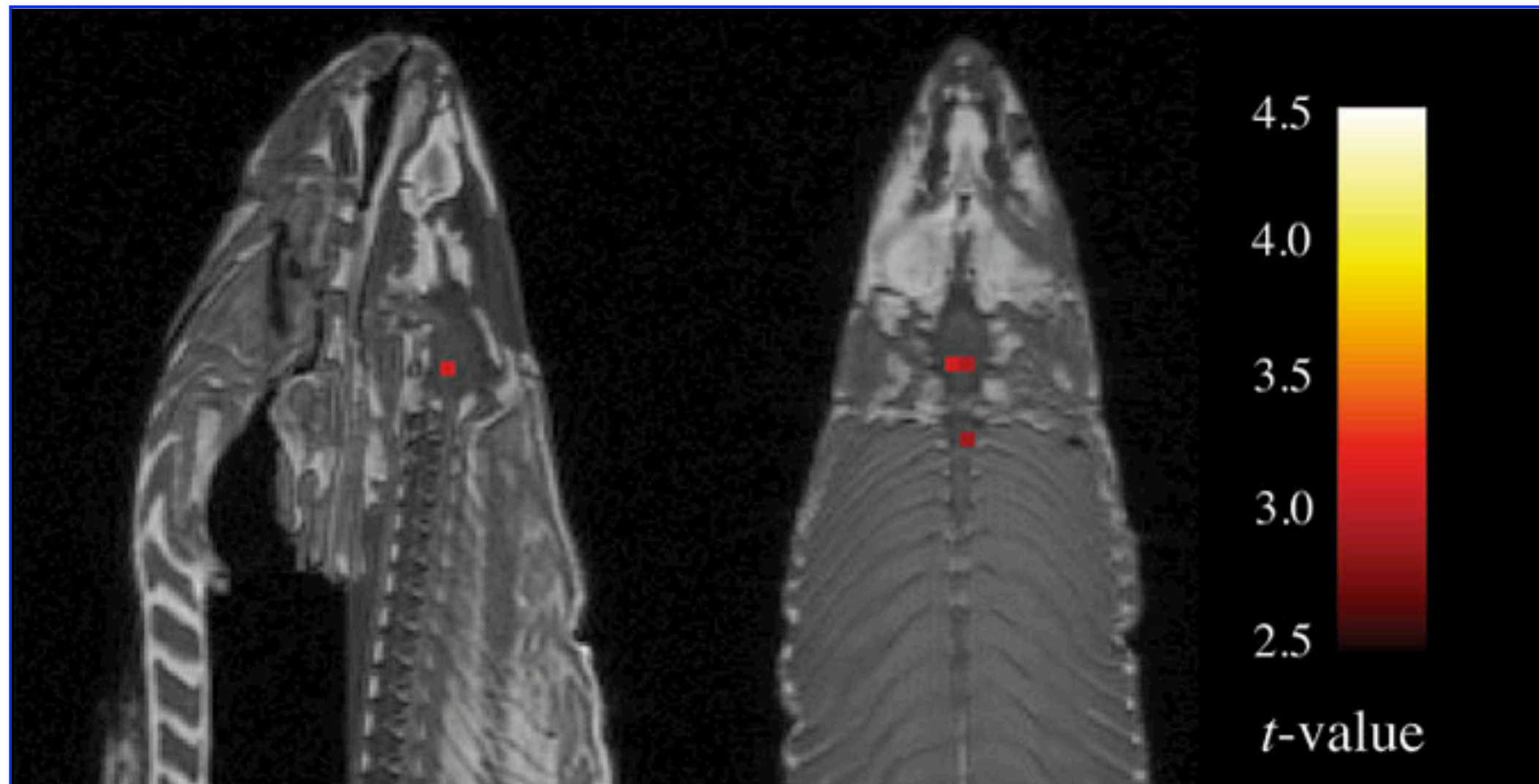
[Previous post](#)

[Next post](#)

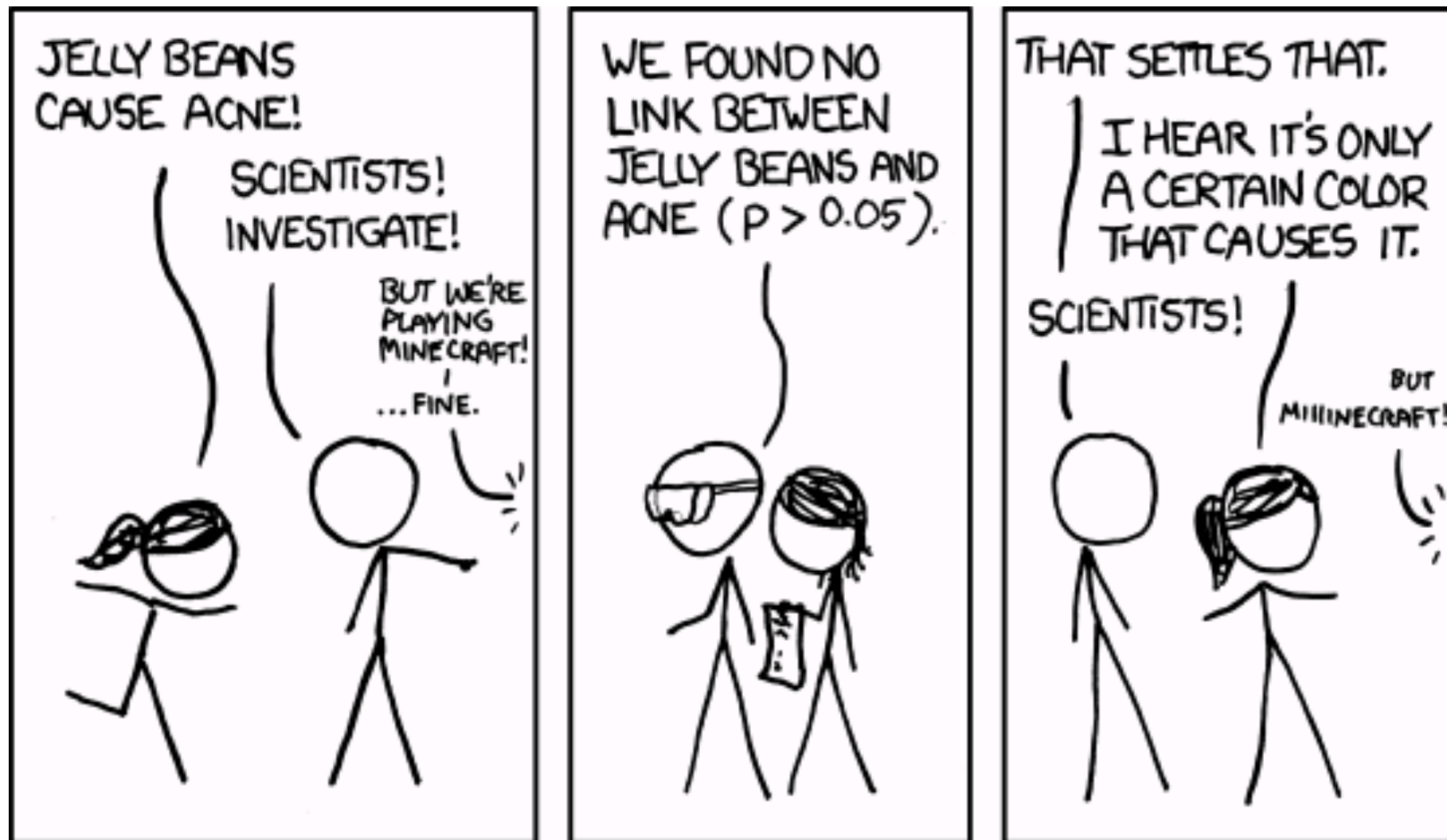
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Scanning Dead Salmon in fMRI Machine Highlights Risk of Red Herrings

By [Alexis Madrigal](#)  September 18, 2009 | 5:37 pm | Categories: [Brains and Behavior](#)



The Multiple Testing Problem



<http://xkcd.com/882/>

WE FOUND NO
LINK BETWEEN
PURPLE JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND NO
LINK BETWEEN
BROWN JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND NO
LINK BETWEEN
PINK JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND NO
LINK BETWEEN
BLUE JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND NO
LINK BETWEEN
TEAL JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND NO
LINK BETWEEN
GREY JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND NO
LINK BETWEEN
TAN JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND NO
LINK BETWEEN
CYAN JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND A
LINK BETWEEN
GREEN JELLY
BEANS AND AONE
($P < 0.05$).



WE FOUND NO
LINK BETWEEN
MAUVE JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND NO
LINK BETWEEN
SALMON JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND NO
LINK BETWEEN
RED JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND NO
LINK BETWEEN
TURQUOISE JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND NO
LINK BETWEEN
MAGENTA JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND NO
LINK BETWEEN
YELLOW JELLY
BEANS AND AONE
($P > 0.05$).



WE FOUND NO
LINK BETWEEN
BEIGE JELLY
BEANS AND AONE
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WE FOUND NO
LINK BETWEEN
LILAC JELLY
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WE FOUND NO
LINK BETWEEN
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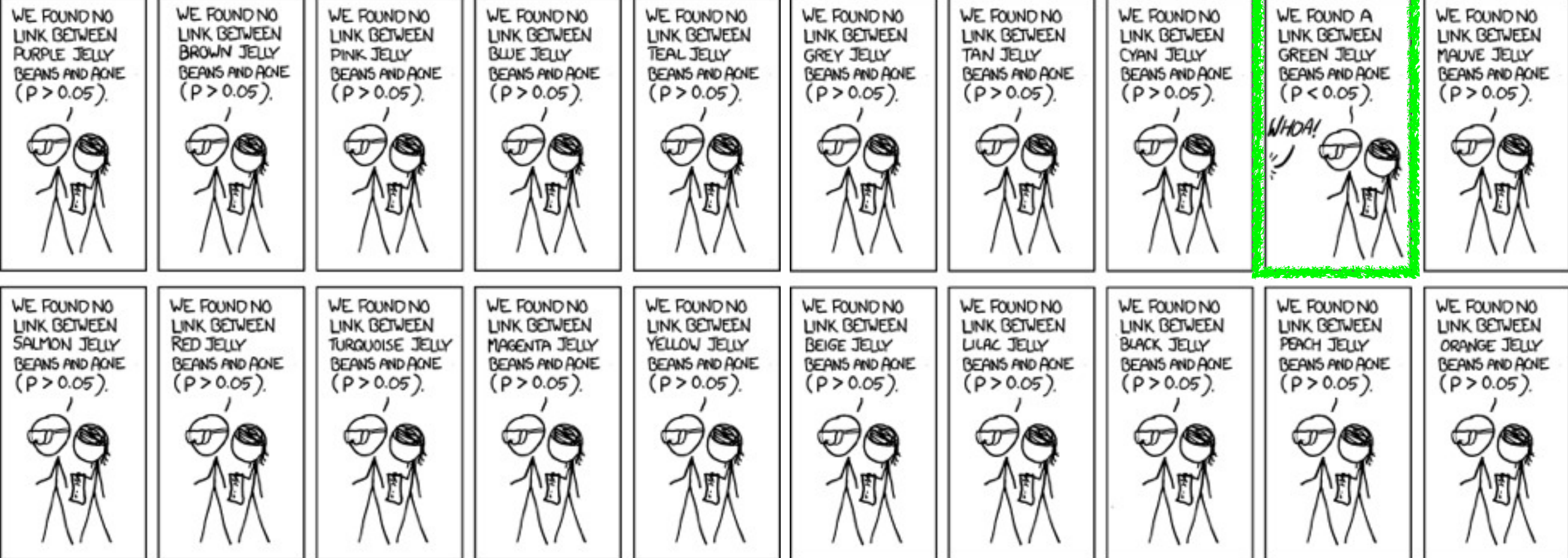


WE FOUND NO
LINK BETWEEN
PEACH JELLY
BEANS AND AONE
($P > 0.05$).




WE FOUND NO
LINK BETWEEN
ORANGE JELLY
BEANS AND AONE
($P > 0.05$).






WE FOUND NO LINK BETWEEN PURPLE JELLY BEANS AND ACNE ($P > 0.05$).




WE FOUND NO LINK BETWEEN BROWN JELLY BEANS AND ACNE ($P > 0.05$).




WE FOUND NO LINK BETWEEN PINK JELLY BEANS AND ACNE ($P > 0.05$).



WE FOUND NO LINK BETWEEN SALMON JELLY BEANS AND ACNE ($P > 0.05$).



WE FOUND NO LINK BETWEEN RED JELLY BEANS AND ACNE ($P > 0.05$).



WE FOUND NO LINK BETWEEN TURQUOISE JELLY BEANS AND ACNE ($P > 0.05$).



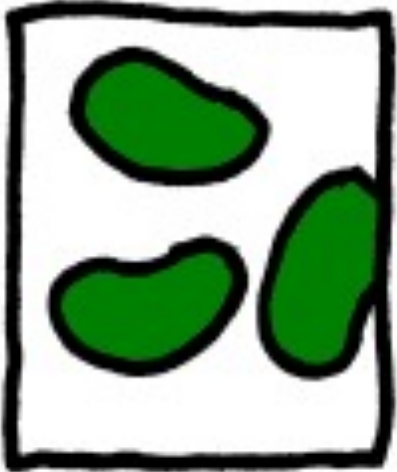
News

GREEN JELLY BEANS LINKED TO ACNE!


95% CONFIDENCE

ONLY 5% CHANCE OF COINCIDENCE!

SCIENTISTS...




WE FOUND NO LINK BETWEEN LILAC JELLY BEANS AND ACNE ($P > 0.05$).




WE FOUND A LINK BETWEEN GREEN JELLY BEANS AND ACNE ($P < 0.05$).


WHOA!




WE FOUND NO LINK BETWEEN MAUVE JELLY BEANS AND ACNE ($P > 0.05$).




WE FOUND NO LINK BETWEEN BLACK JELLY BEANS AND ACNE ($P > 0.05$).



WE FOUND NO LINK BETWEEN PEACH JELLY BEANS AND ACNE ($P > 0.05$).



WE FOUND NO LINK BETWEEN ORANGE JELLY BEANS AND ACNE ($P > 0.05$).



Single Experiment Model

$$y_i = x_i + z_i, \quad i = 1, \dots, n$$

$$z_i \stackrel{\text{iid}}{\sim} \mathcal{N}(0, 1)$$

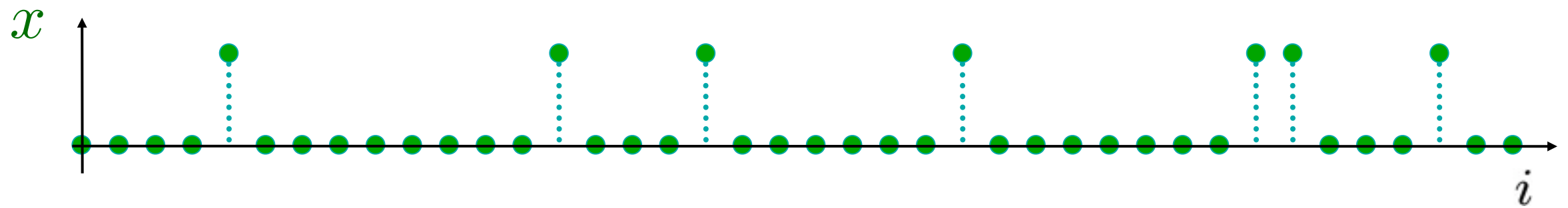
sparsity: $x_i = 0$ except on a small subset $\mathcal{S} \subset \{1, \dots, n\}$ where $x_i = \mu > 0$

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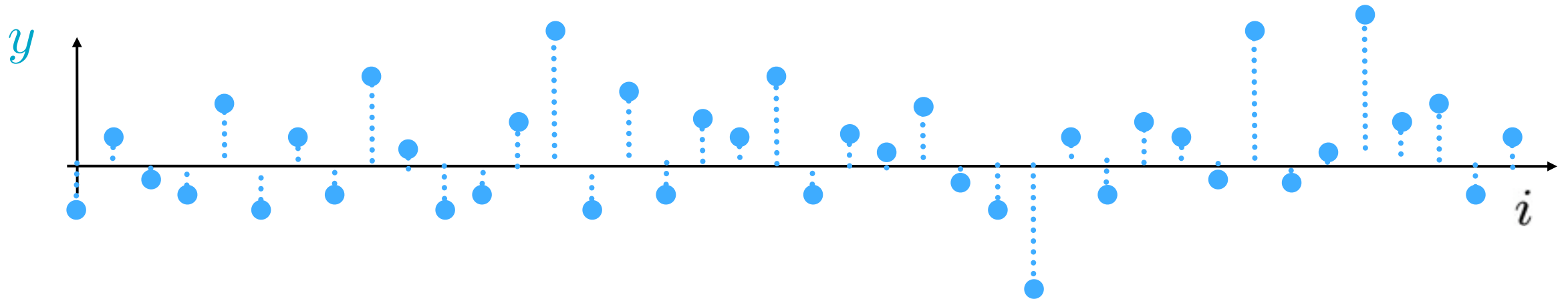


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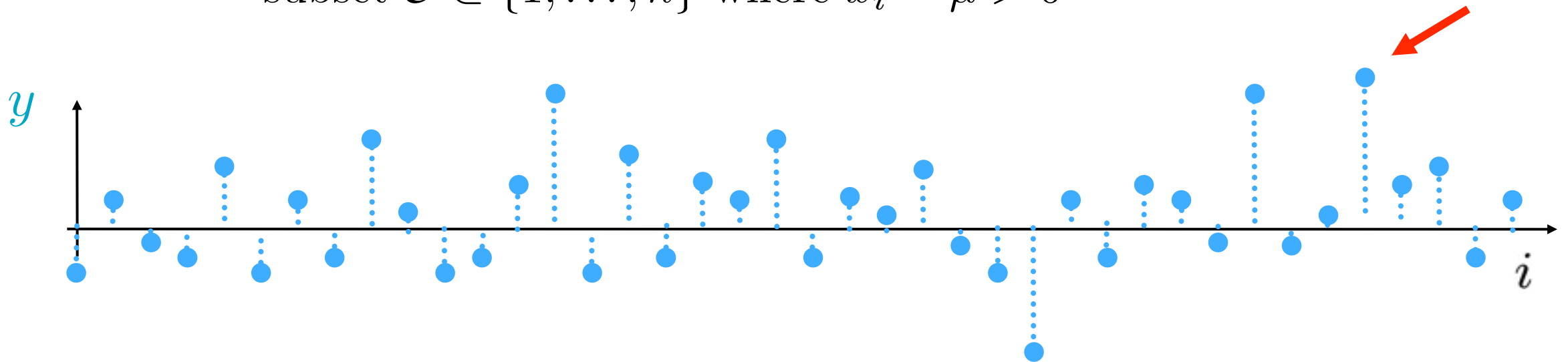


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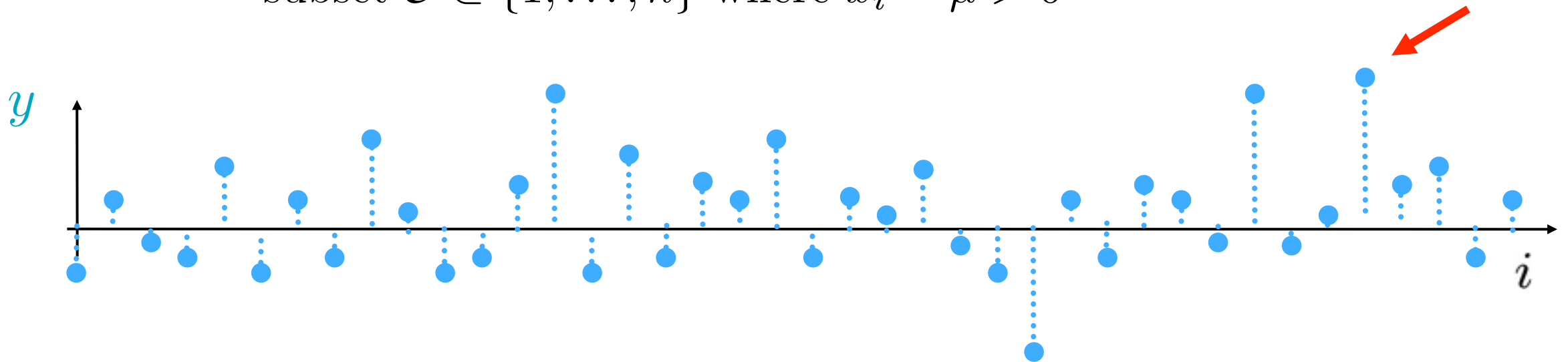
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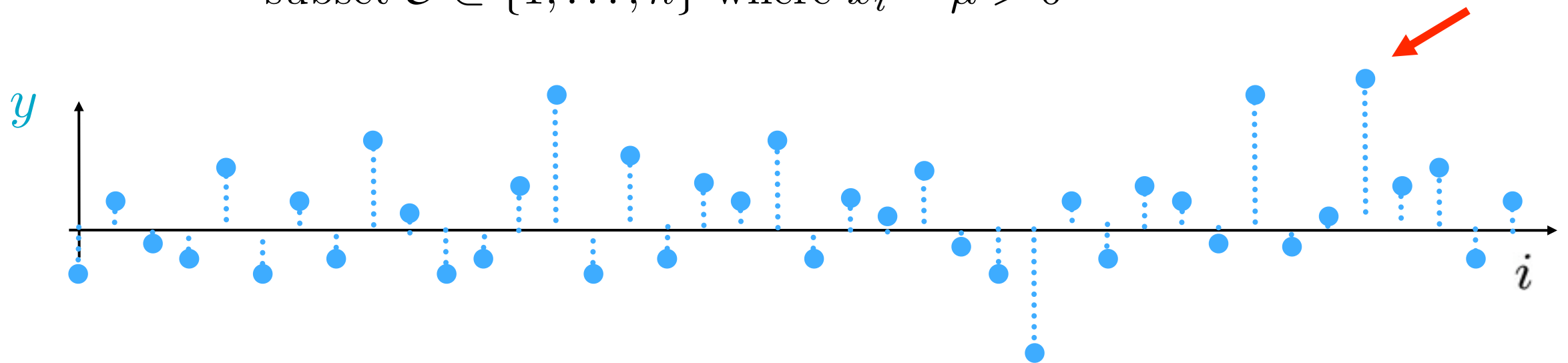
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Even if no signal is present, $\max_i y_i \sim \sqrt{2 \log n}$

It is *impossible* to reliably detect signal components if $\mu < \sqrt{2 \log n}$

An Alternative: Sequential Experimental Design

Instead of the usual non-adaptive observation model

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suppose we are able to sequentially collect several **independent** measurements of each component of x , according to

$$y_{i,j} = x_i + \gamma_{i,j}^{-1/2} z_{i,j}, \quad i = 1, \dots, n, \quad j = 1, \dots, k$$

where

j indexes the measurement steps

k denotes the total number of steps

$$z_{i,j} \stackrel{\text{iid}}{\sim} \mathcal{N}(0, 1)$$

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Total precision budget is constrained, but the choice of $\gamma_{i,j}$ can depend on past observations $\{y_{i,\ell}\}_{\ell < j}$.

Experimental (Precision) Budget

sequential measurement model

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The precision parameters $\{\gamma_{i,j}\}$ are required to satisfy

$$\sum_{j=1}^k \sum_{i=1}^n \gamma_{i,j} \leq n$$

For example, the usual non-adaptive, single measurement model corresponds to taking $k = 1$, and $\gamma_{i,1} = 1$, $i = 1, \dots, n$. This baseline can be compared with adaptive procedures by allowing $k > 1$ and variable $\{\gamma_{i,j}\}$ satisfying budget.

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allocate precision sequentially and adaptively

Sequential Thresholding

Sequential Thresholding

initialize: $\mathcal{S}_0 = \{1, \dots, n\}$, $\gamma_{i,j}^{-1} = 2$

for $j = 1, \dots, k$

1) **measure:** $y_{i,j} \sim \mathcal{N}(x_i, 2)$, $i \in \mathcal{S}_{j-1}$

2) **threshold:** $\mathcal{S}_j = \{i : y_{i,j} \geq 0\}$

end

output: $\mathcal{S}_k = \{i : y_{i,k} > 0\}$

Sequential Thresholding

$$\text{precision} = \begin{cases} \frac{1}{2} & , \text{ if measured} \\ 0 & , \text{ otherwise} \end{cases}$$

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 $s := |\mathcal{S}|$

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define the *sparsity level*

$$s := |\mathcal{S}|$$

total precision budget: $\mathbb{E} \left[\sum_{i,j} \gamma_{i,j} \right]$

$$= \frac{1}{2} \sum_{j=1}^k \mathbb{E} |\mathcal{S}_{j-1}|$$

$$\leq \frac{1}{2} \sum_{j=1}^k \left(\frac{n-s}{2^{j-1}} + s \right)$$

$$\leq n - s + ks \approx n$$

(when $n \gg s$)

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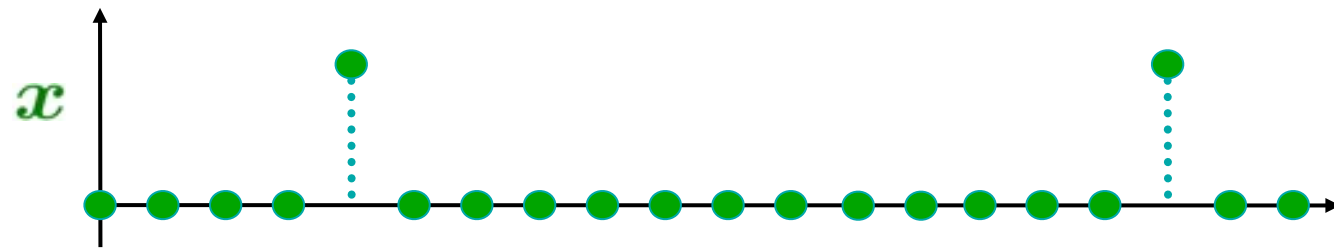
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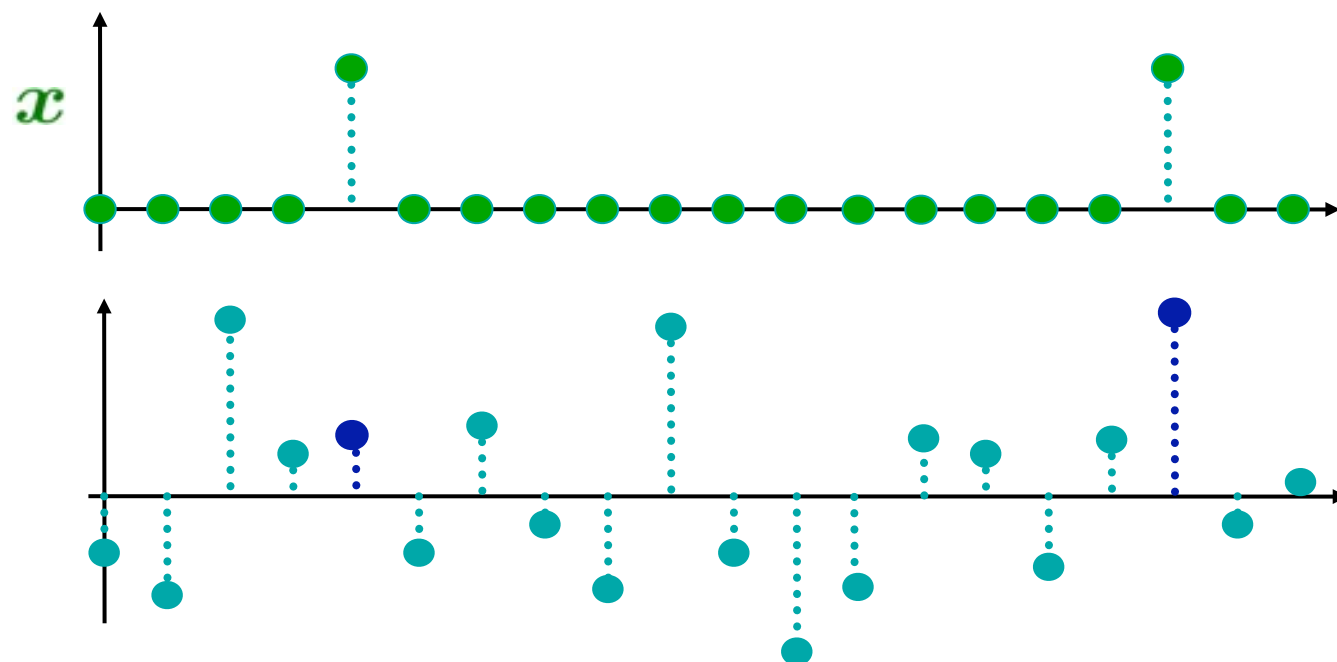
(when $n \gg s$)

$$\begin{aligned} \text{probability of error: } \mathbb{P}(\mathcal{S}_k \neq \mathcal{S}) &= \mathbb{P}(\{\mathcal{S}^c \cap \mathcal{S}_k \neq \emptyset\} \cup \{\mathcal{S} \cap \mathcal{S}_k^c \neq \emptyset\}) \\ &\leq \mathbb{P}(\mathcal{S}^c \cap \mathcal{S}_k \neq \emptyset) + \mathbb{P}(\mathcal{S} \cap \mathcal{S}_k^c \neq \emptyset) \end{aligned}$$

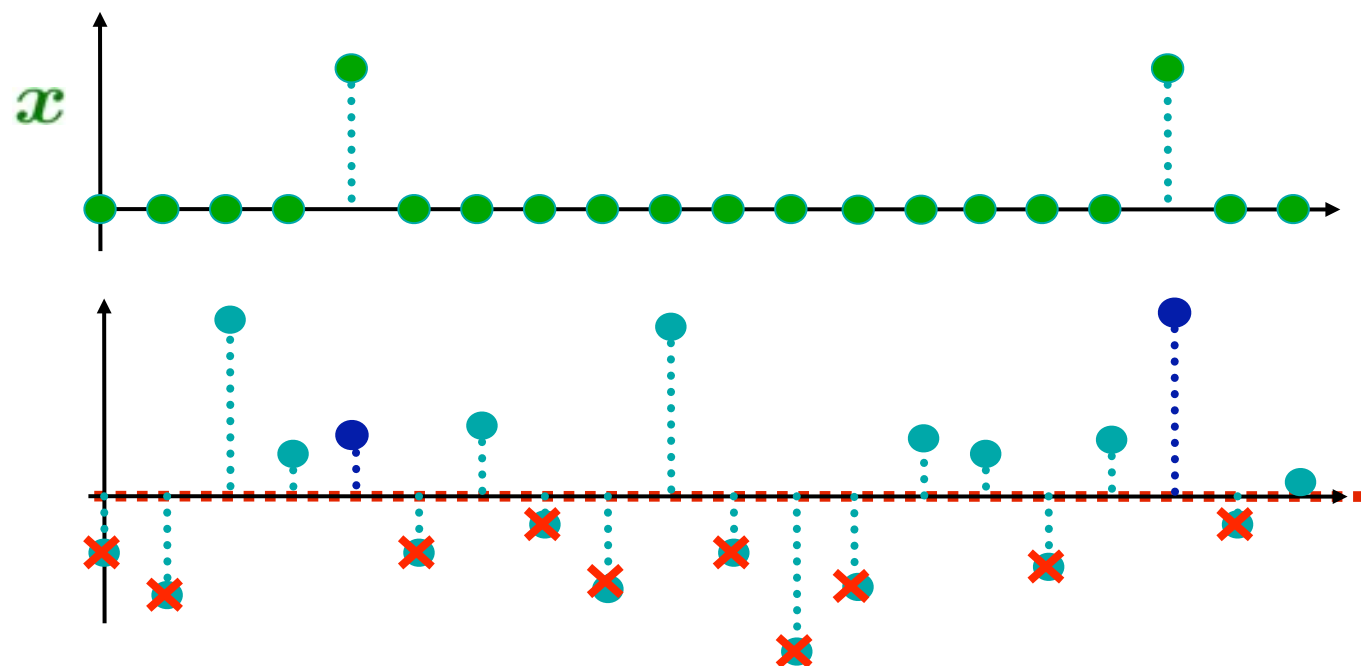
Idealized Example



Idealized Example

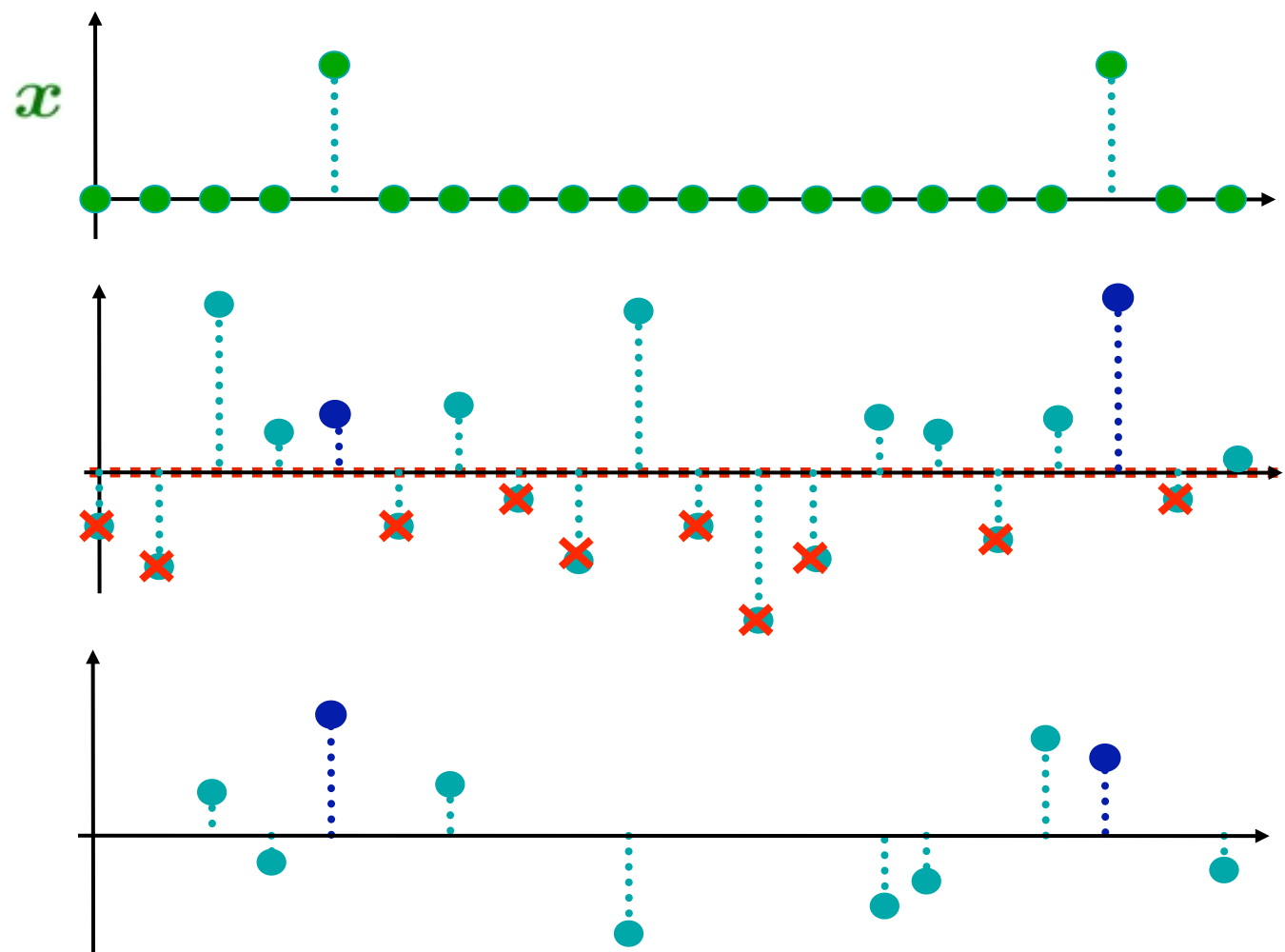


Idealized Example



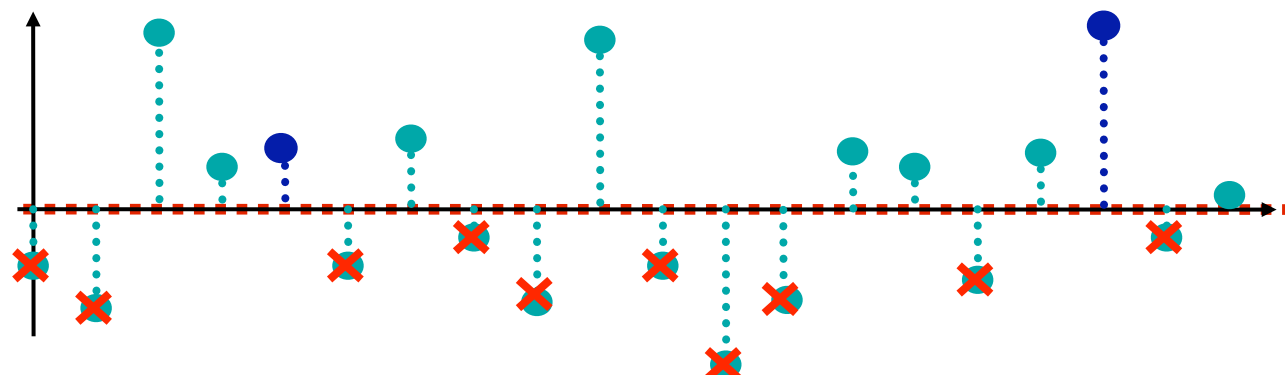
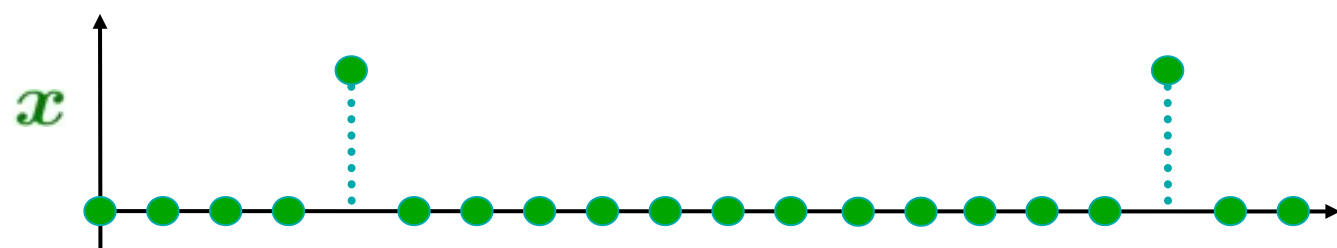
threshold at zero and re-measure
only those components that survive

Idealized Example

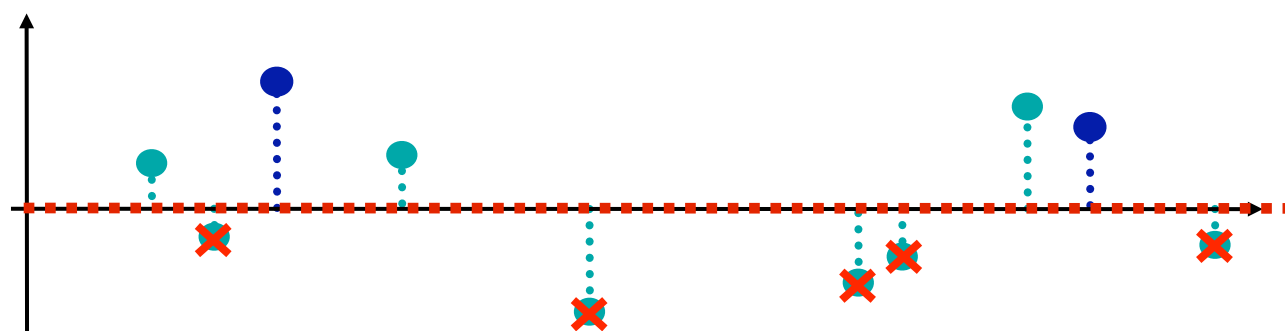


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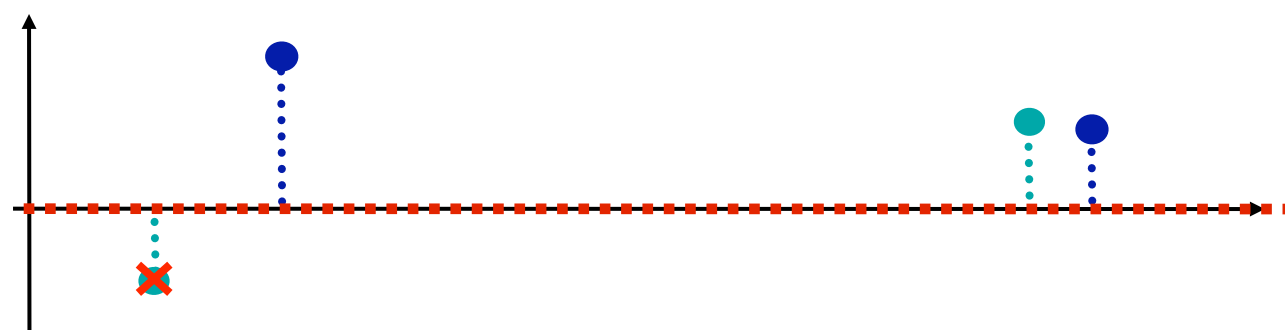
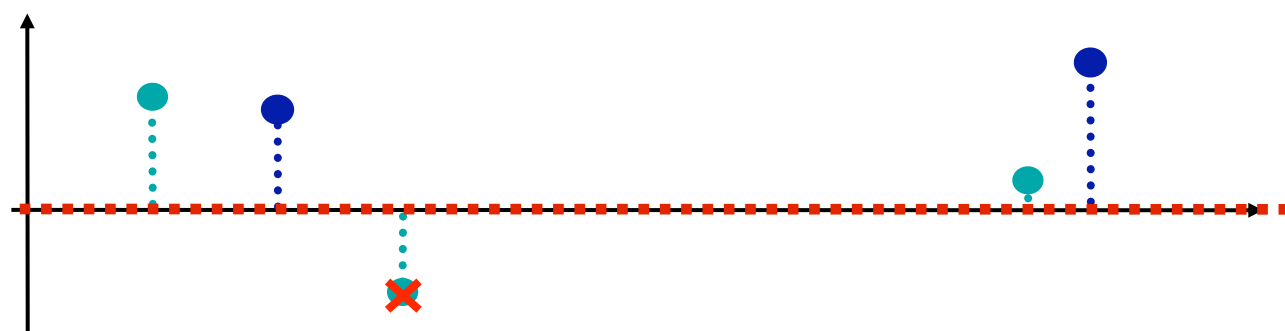
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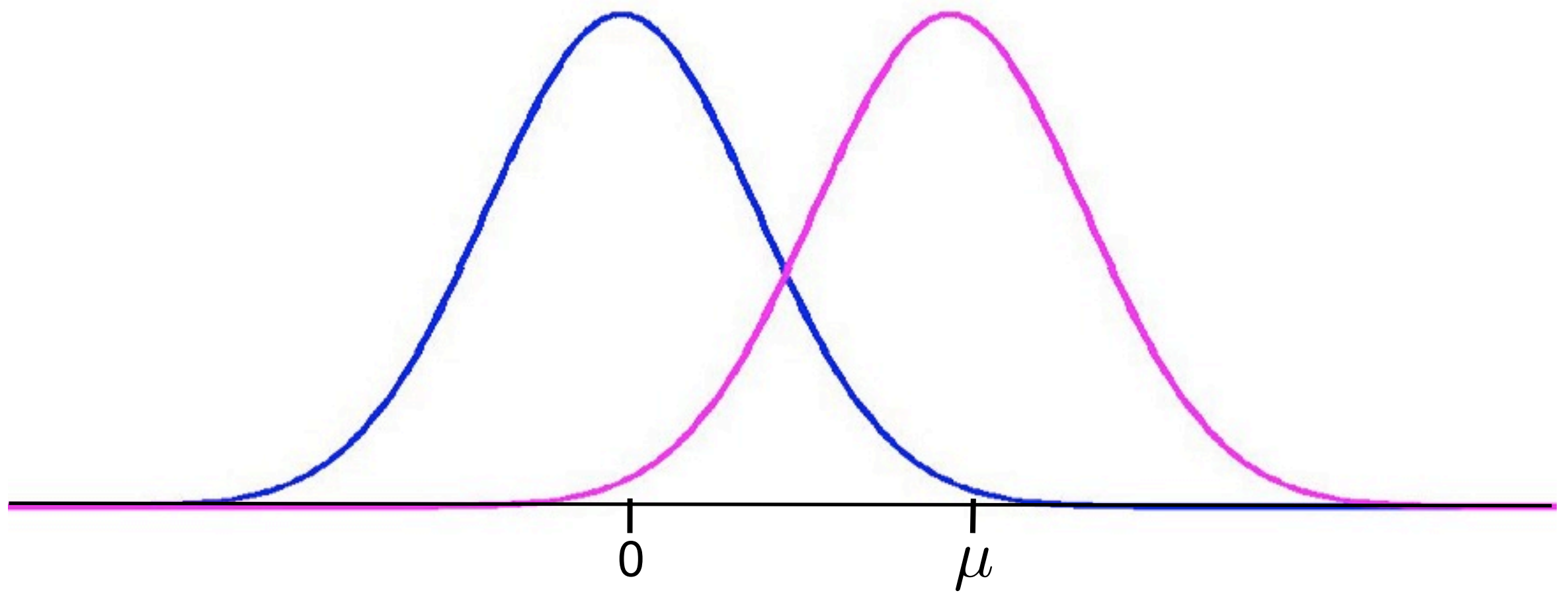


repeat several times

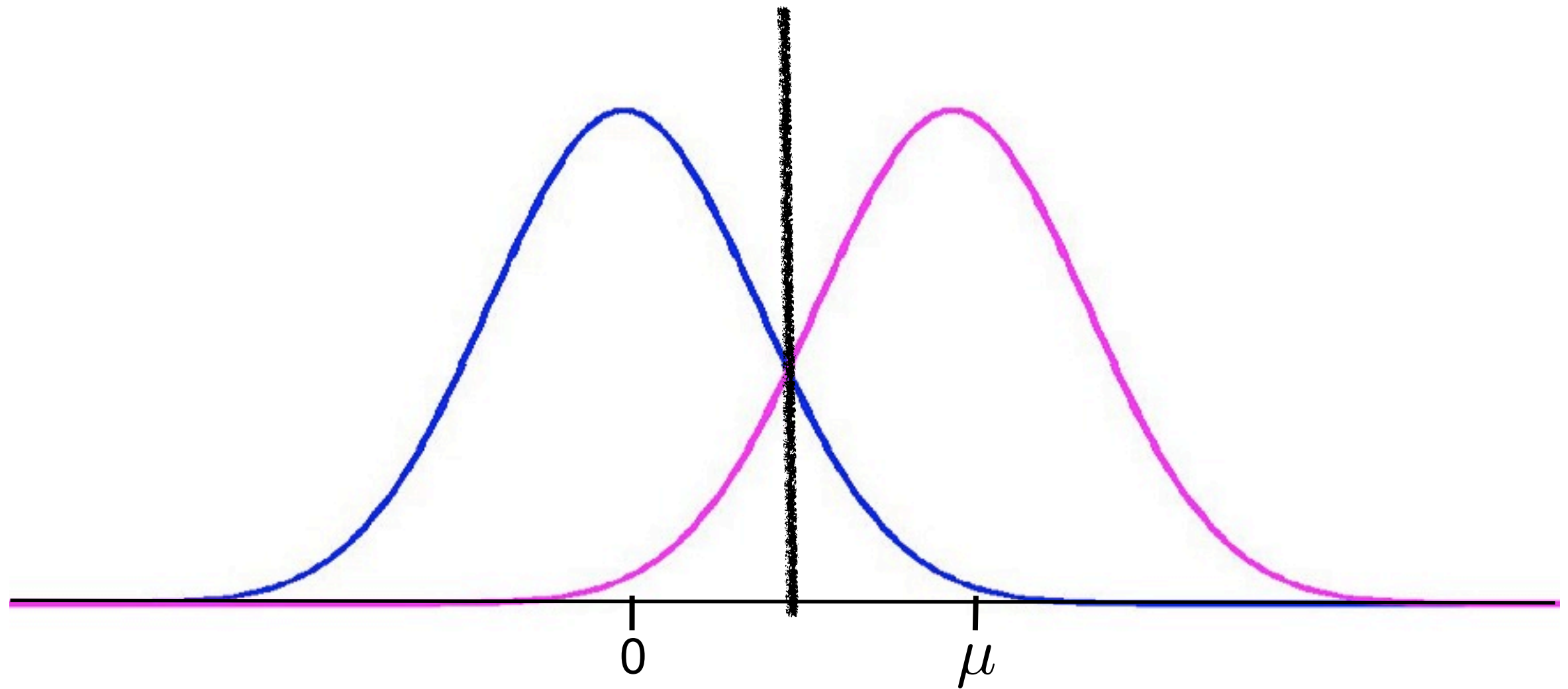


most of true signal components
survive several thresholding
steps, almost all of noise
components do not

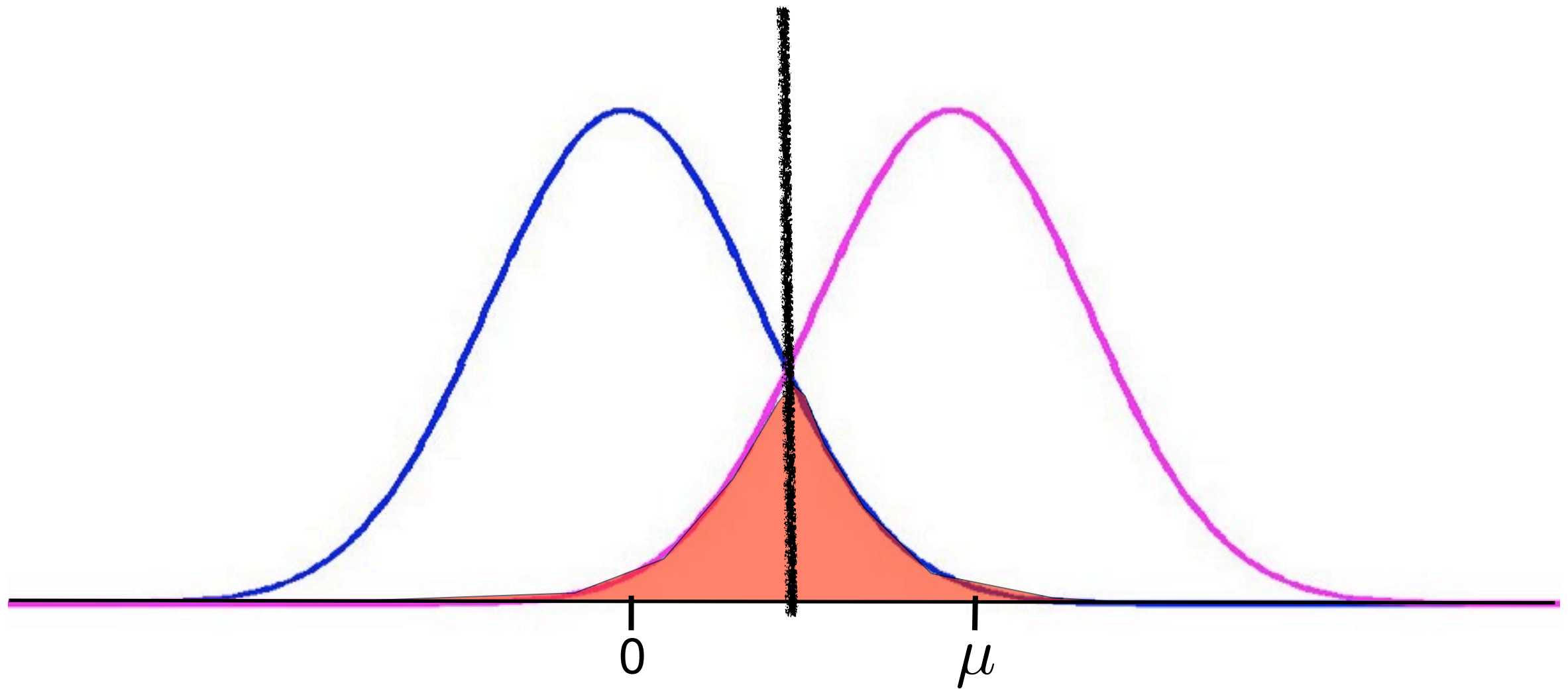
Low False-Negative, High False-Positive Rates



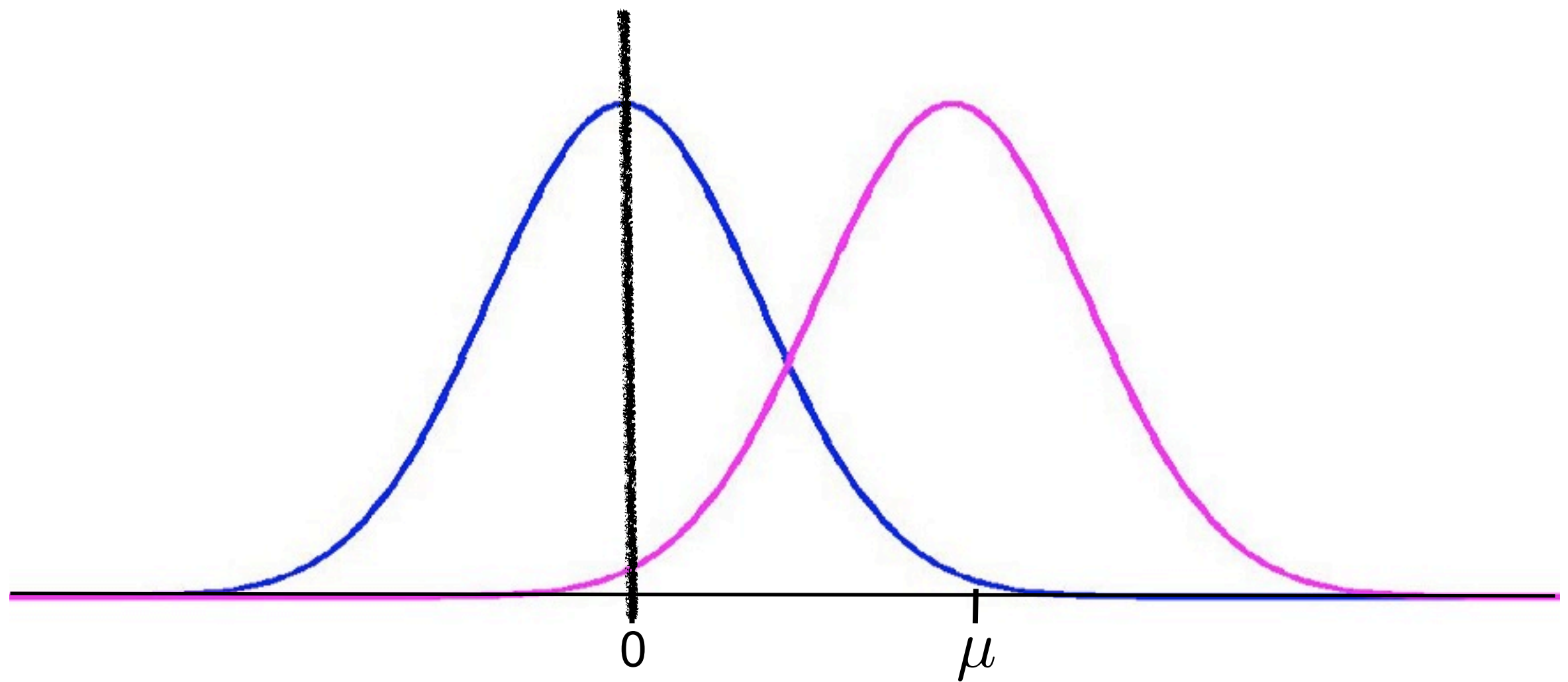
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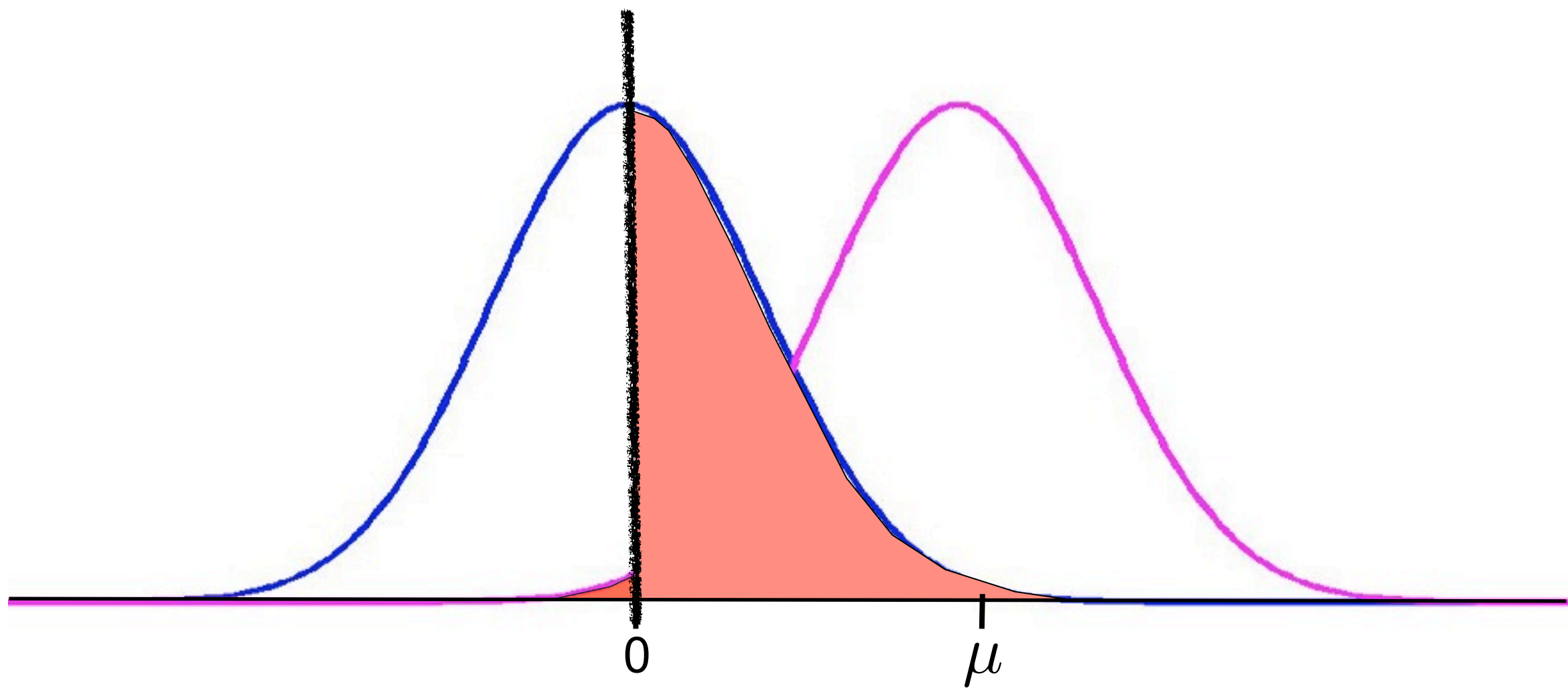
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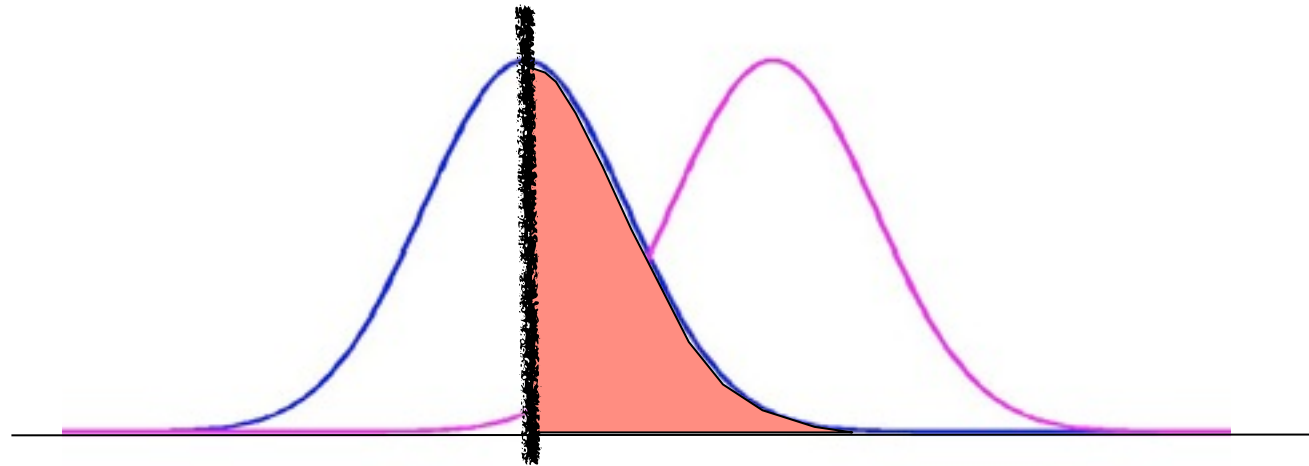
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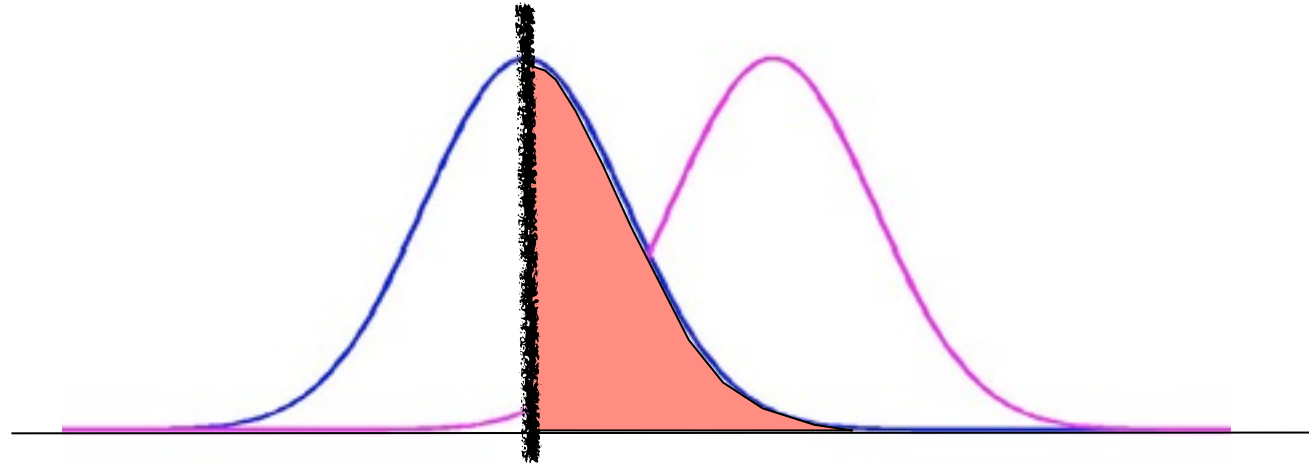


False Positives



$$\mathbb{P}(\mathcal{S}_k \neq \mathcal{S}) \leq \mathbb{P}(\mathcal{S}^c \cap \mathcal{S}_k \neq \emptyset) + \mathbb{P}(\mathcal{S} \cap \mathcal{S}_k^c \neq \emptyset)$$

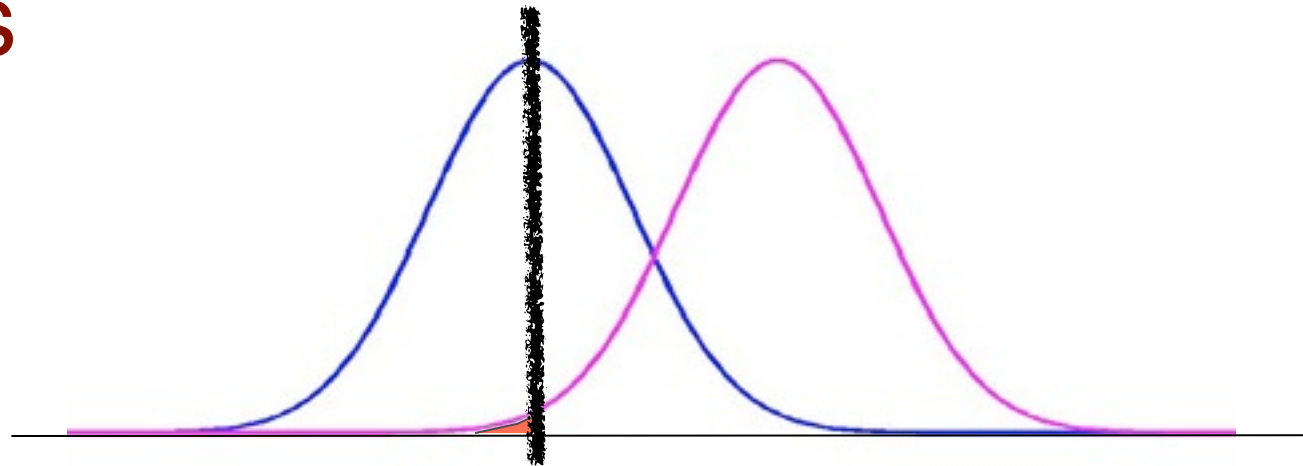
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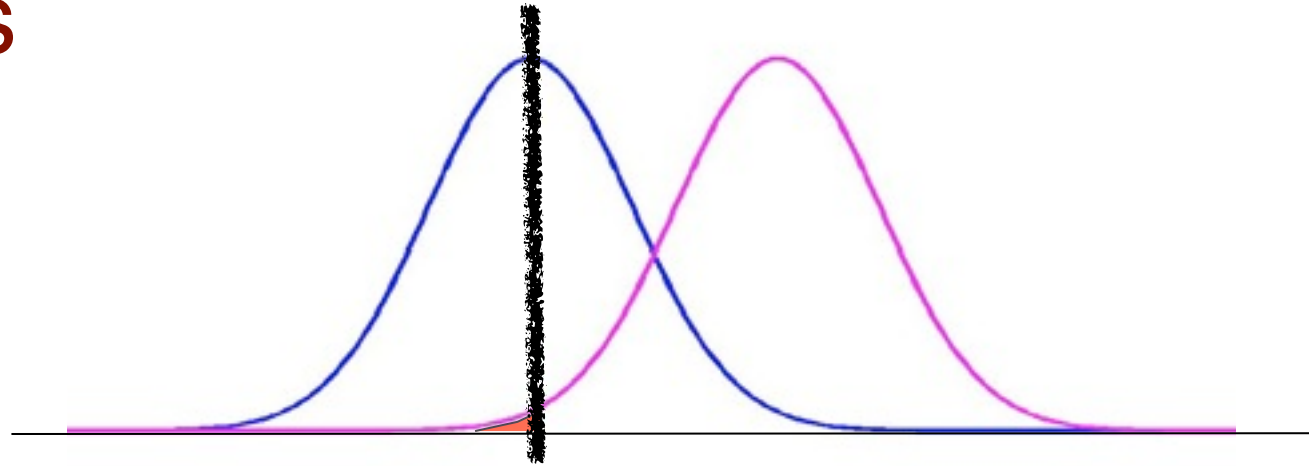
$$\begin{aligned} \mathbb{P}(\mathcal{S}^c \cap \mathcal{S}_k \neq \emptyset) &= \mathbb{P}\left(\bigcup_{i \notin \mathcal{S}} \bigcap_{j=1}^k y_{i,j} > 0\right) \\ &\leq \sum_{i \notin \mathcal{S}} \mathbb{P}\left(\bigcap_{j=1}^k y_{i,j} > 0\right) \\ &= \sum_{i \notin \mathcal{S}} 2^{-k} = \frac{n - s}{2^k} \end{aligned}$$

False Negatives



$$\mathbb{P}(\mathcal{S}_k \neq \mathcal{S}) \leq \mathbb{P}(\mathcal{S}^c \cap \mathcal{S}_k \neq \emptyset) + \mathbb{P}(\mathcal{S} \cap \mathcal{S}_k^c \neq \emptyset)$$

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$$\begin{aligned} \mathbb{P}(\mathcal{S} \cap \mathcal{S}_k^c \neq \emptyset) &= \mathbb{P}\left(\bigcup_{j=1}^k \bigcup_{i \in \mathcal{S}} y_{i,j} < 0\right) \\ &\leq \frac{ks}{2} \exp\left(-\frac{\mu^2}{4}\right) \end{aligned}$$

Probability of Error Bound

$$\begin{aligned}\mathbb{P}(\mathcal{S}_k \neq \mathcal{S}) &\leq \mathbb{P}(\mathcal{S}^c \cap \mathcal{S}_k \neq \emptyset) + \mathbb{P}(\mathcal{S} \cap \mathcal{S}_k^c \neq \emptyset) \\ &\leq \frac{n-s}{2^k} + \frac{ks}{2} \exp\left(-\frac{\mu^2}{4}\right) \\ &= \frac{n-s}{2^k} + \frac{1}{2} \exp\left(-\frac{(\mu^2 - 4 \log(ks))}{4}\right)\end{aligned}$$

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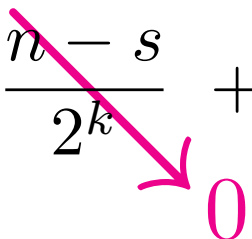
Consider high-dimensional limit as $n \rightarrow \infty$ and take $k = \log_2 n^{1+\epsilon}$

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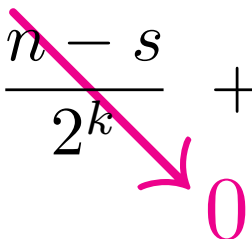
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Second term tends to zero if

$$\mu \geq \sqrt{c \log(s \log_2 n)}, \text{ for any } c > 4$$

Gains of Sequential Design



Rui Castro
(Eindhoven)



Jarvis Haupt
(Minnesota)



Matt Malloy
(Madison)

non-sequential: $\mu > \sqrt{2 \log n}$ (necessary)

sequential thresholding: (sufficient)

$$\mu > \sqrt{4(\log s + \log \log_2 n)}$$

with a bit more work we can show

$$\mu > \sqrt{2(\log s + \log \log_2 \log n)} \text{ suffices}$$

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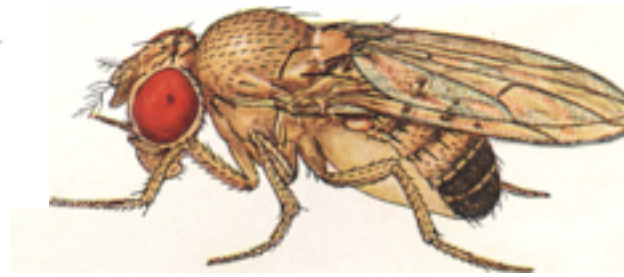
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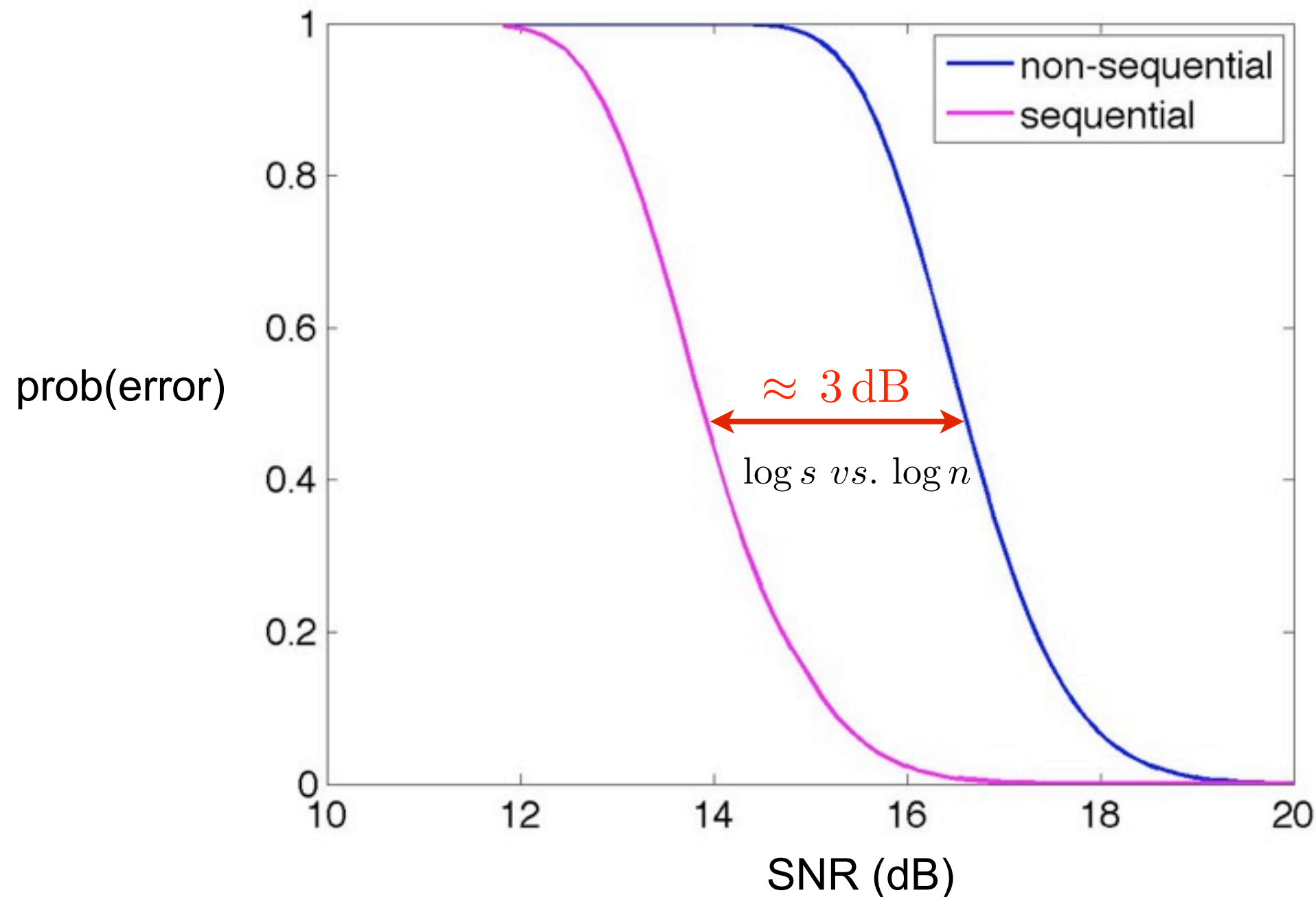
significant gains when $s \ll n$

greater sensitivity for same precision budget or lower
experimental requirements for equivalent sensitivity

Biology Example

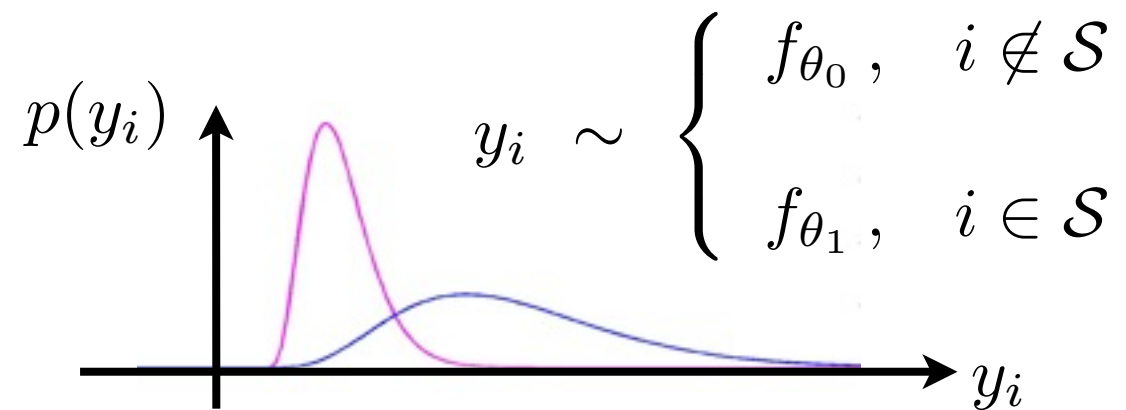


13,071 single-gene
knock-down cell strains



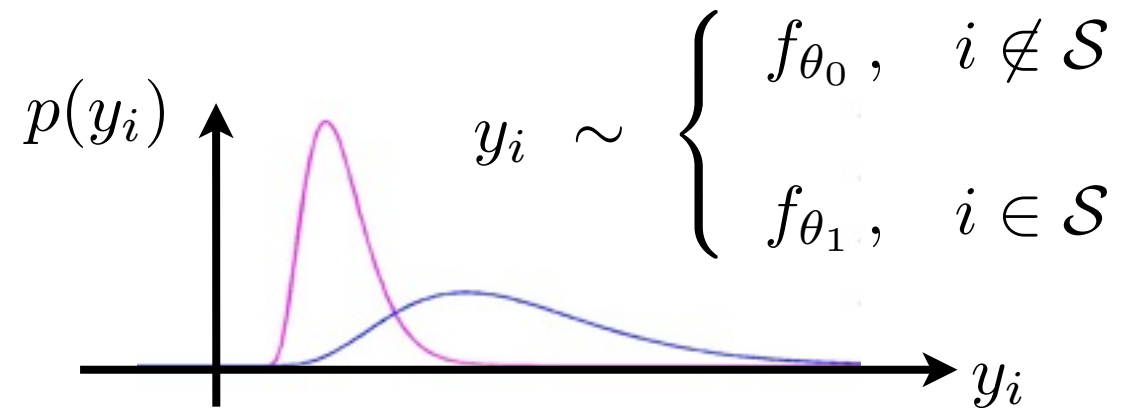
sequential thresholding is about twice as sensitive (for equal experimental budget)
or requires half the number experiments (for same sensitivity)

Lower Bound



assume f_{θ_0} , f_{θ_1} and
sparsity level s are known

Lower Bound



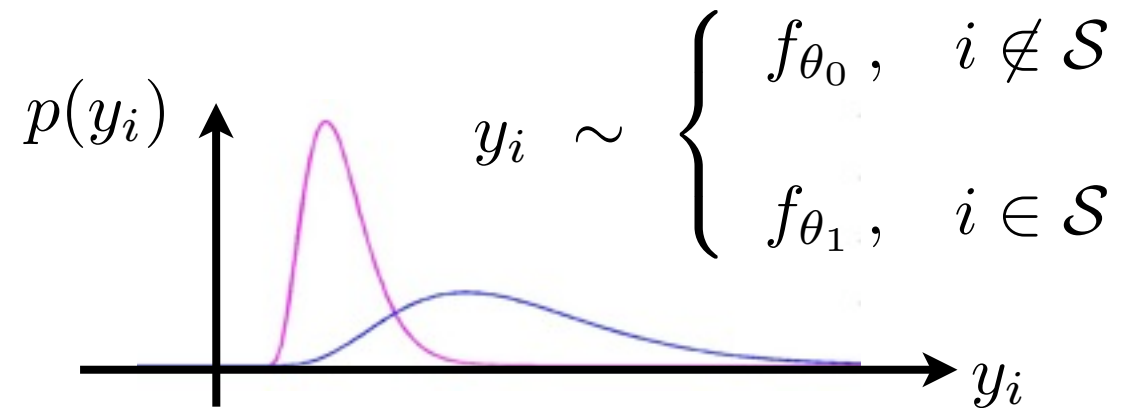
assume f_{θ_0} , f_{θ_1} and
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specify error rates (per-test):

false-positive probability: $\alpha = \epsilon/(n - s)$

false-negative probability: $\beta = \epsilon/s$

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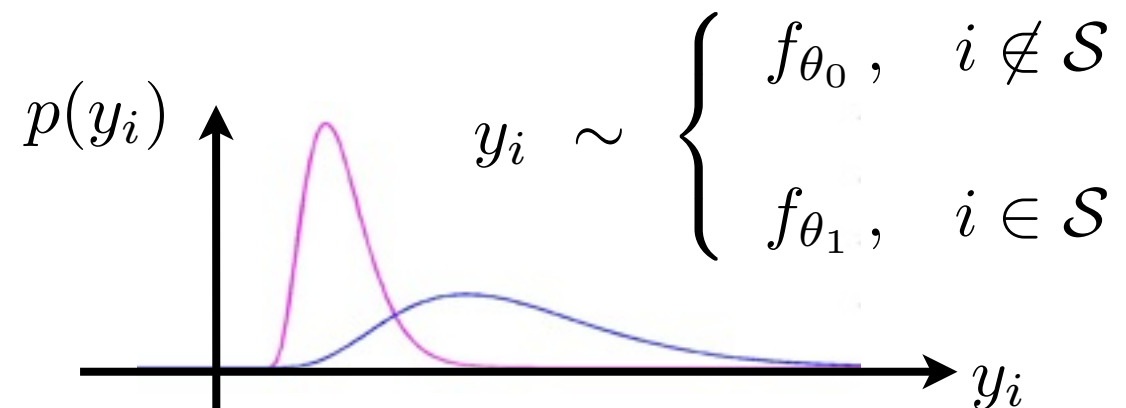
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expected number of errors: $\alpha (n - s) + \beta s = 2\epsilon$

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false-positive probability: $\alpha = \epsilon / (n - s)$

false-negative probability: $\beta = \epsilon / s$

expected number of errors: $\alpha (n - s) + \beta s = 2\epsilon$

expected number samples (precision per-test): for $\alpha, \beta \approx 0$

$$\mathbb{E}_0[M] \gtrsim D_0^{-1} \log \frac{1}{\beta} = D_0^{-1} \log \frac{s}{\epsilon}$$

$$\mathbb{E}_1[M] \gtrsim D_1^{-1} \log \frac{1}{\alpha} = D_1^{-1} \log \frac{n - s}{\epsilon}$$

where D_0, D_1 are KL divergences $D_0 := D(f_{\theta_0} \| f_{\theta_1})$ and $D_1 := D(f_{\theta_1} \| f_{\theta_0})$

Lower Bound

expected total sampling/precision:

$$\mathbb{E}[N] = (n - s)\mathbb{E}_0[M] + s\mathbb{E}_1[M] \gtrsim \frac{n}{D_0} \log \frac{s}{\epsilon}, \text{ when } s \ll n$$

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sampling/precision budget: $\mathbb{E}[N] \leq n \Rightarrow D_0 \geq \log s/\epsilon$

minimum requirement for any testing scheme
with expected sample/precision budget m

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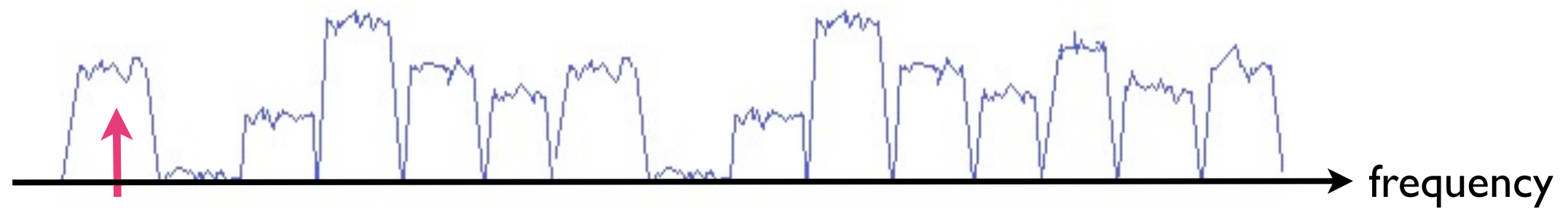
Gaussian case: $N(0, 1)$ vs. $N(\mu, 1) \Rightarrow D_0 = \mu^2/2$ and so $\text{prob}(\text{error}) \leq \epsilon$ iff

$$\mu > \sqrt{2 \log s/\epsilon}$$

sequential thresholding: $\mu > \sqrt{2 (\log s + \log \log_2 \log n)}$

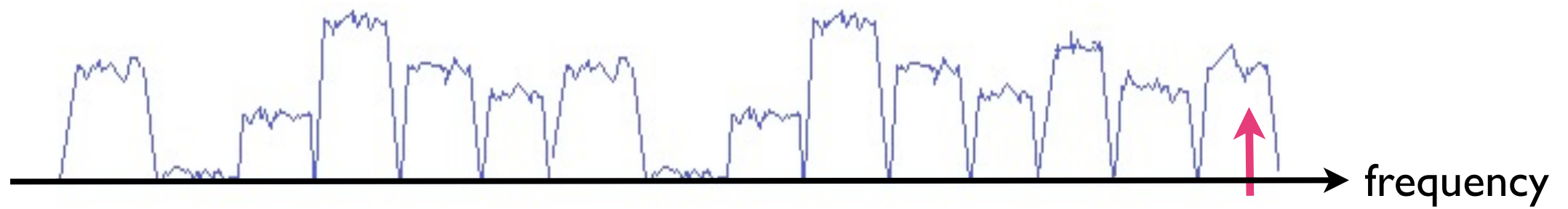
and is adaptive to sparsity level

Spectrum Sensing



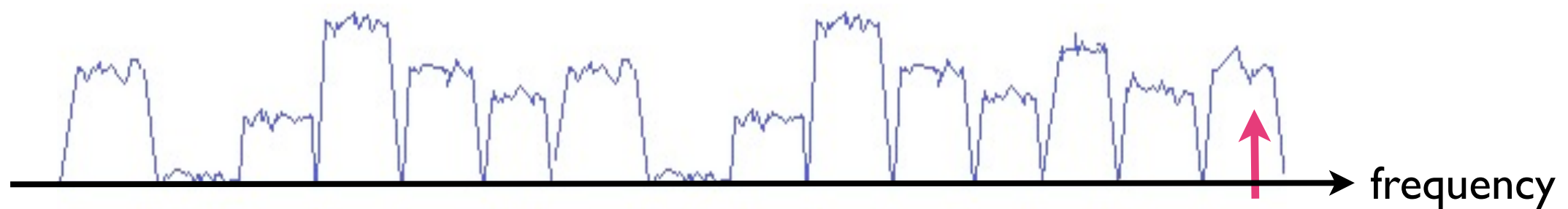
goal: scan to find open channel(s) as quickly as possible

Spectrum Sensing



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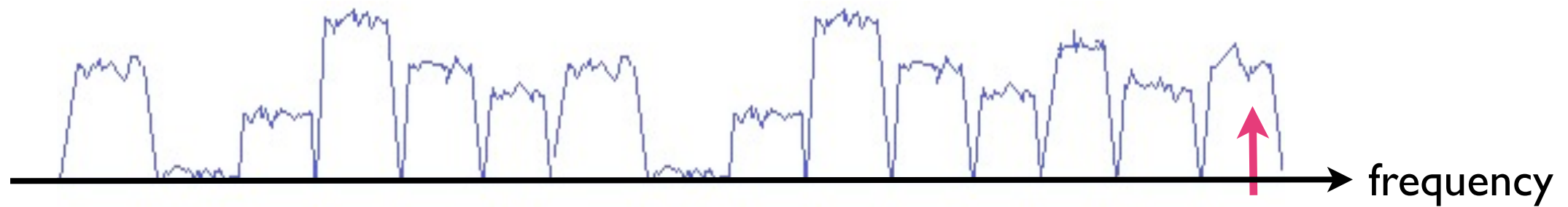
Spectrum Sensing



goal: scan to find open channel(s) as quickly as possible

channel samples: $y_{i,j} \stackrel{\text{iid}}{\sim} \mathcal{CN}(0, \theta)$, $\theta_0 > \theta_1 = 1$

Spectrum Sensing

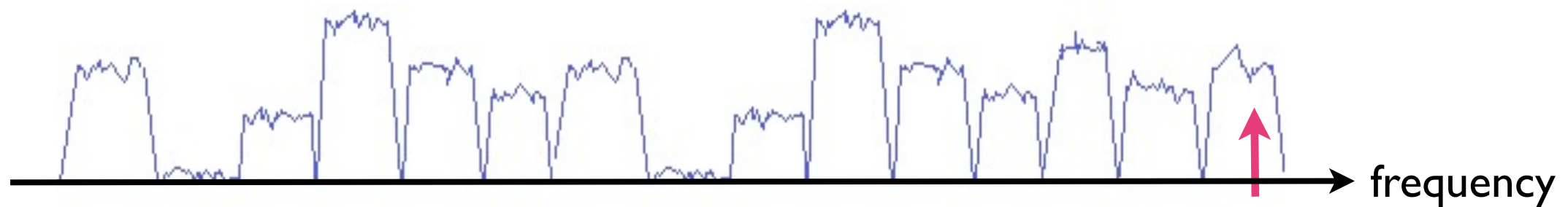


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test statistic: $t_i(m_i) = \sum_{j=1}^{m_i} |y_{i,j}|^2 \sim \begin{cases} \Gamma(m_i, \theta_0), & i \notin \mathcal{S} \\ \Gamma(m_i, 1), & i \in \mathcal{S} \end{cases}$

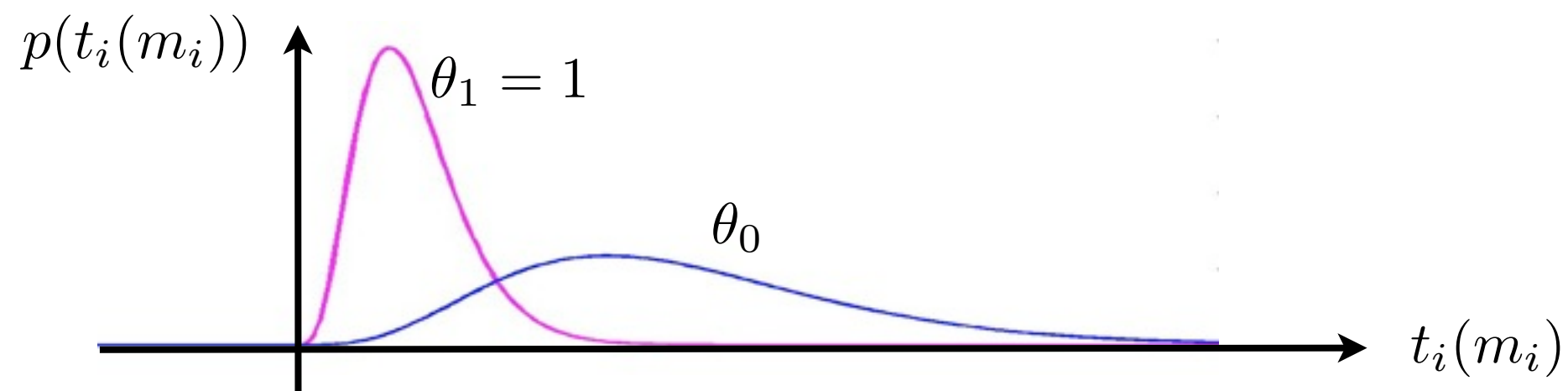
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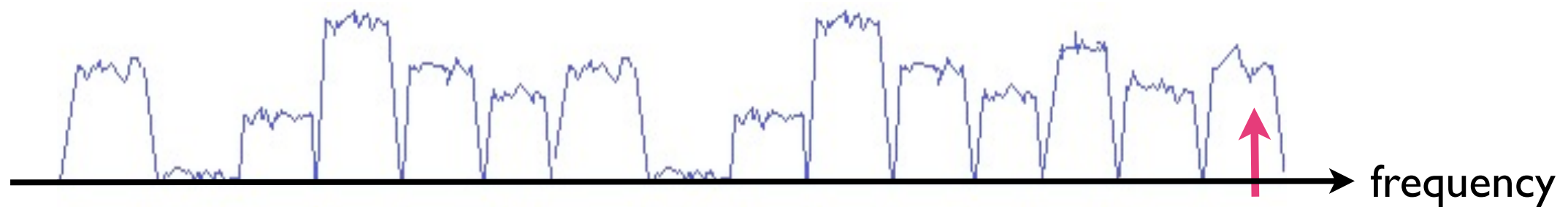
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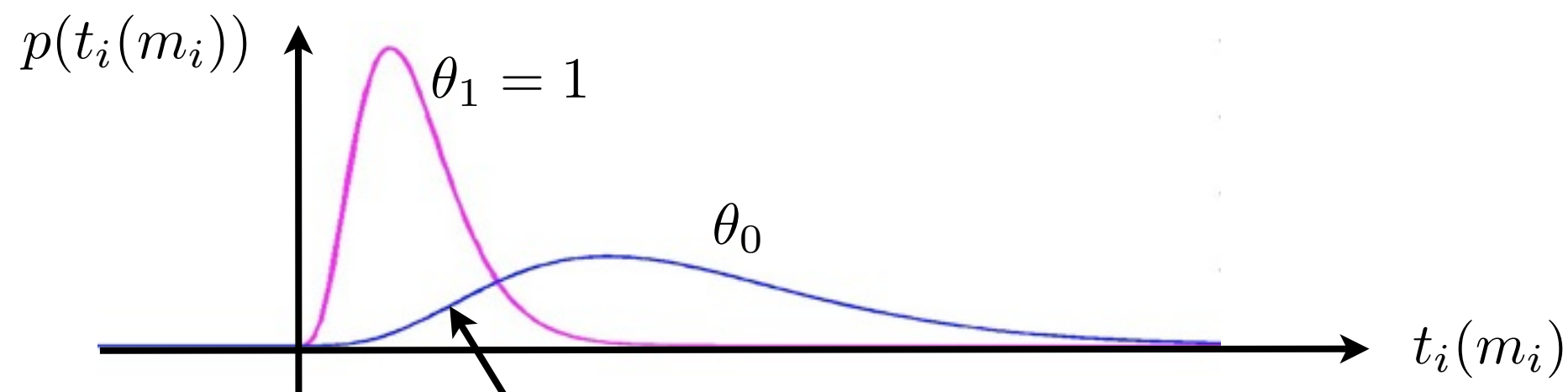
Spectrum Sensing



goal: scan to find open channel(s) as quickly as possible

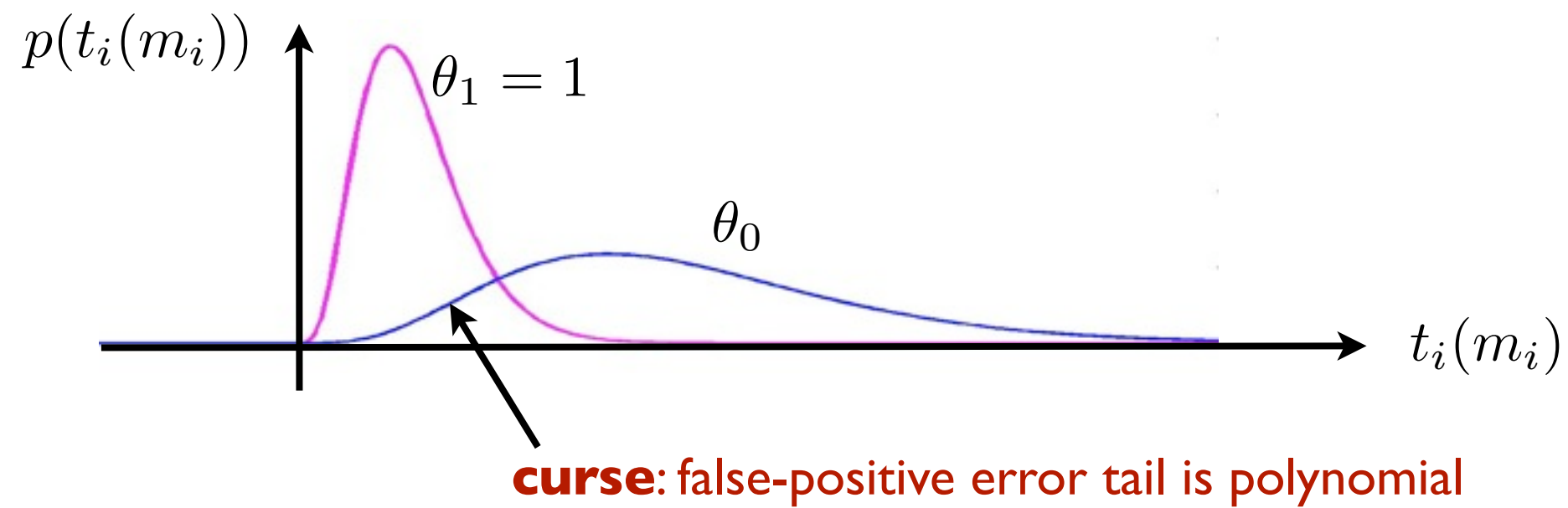
channel samples: $y_{i,j} \stackrel{\text{iid}}{\sim} \mathcal{CN}(0, \theta)$, $\theta_0 > \theta_1 = 1$

test statistic: $t_i(m_i) = \sum_{j=1}^{m_i} |y_{i,j}|^2 \sim \begin{cases} \Gamma(m_i, \theta_0), & i \notin \mathcal{S} \\ \Gamma(m_i, 1), & i \in \mathcal{S} \end{cases}$

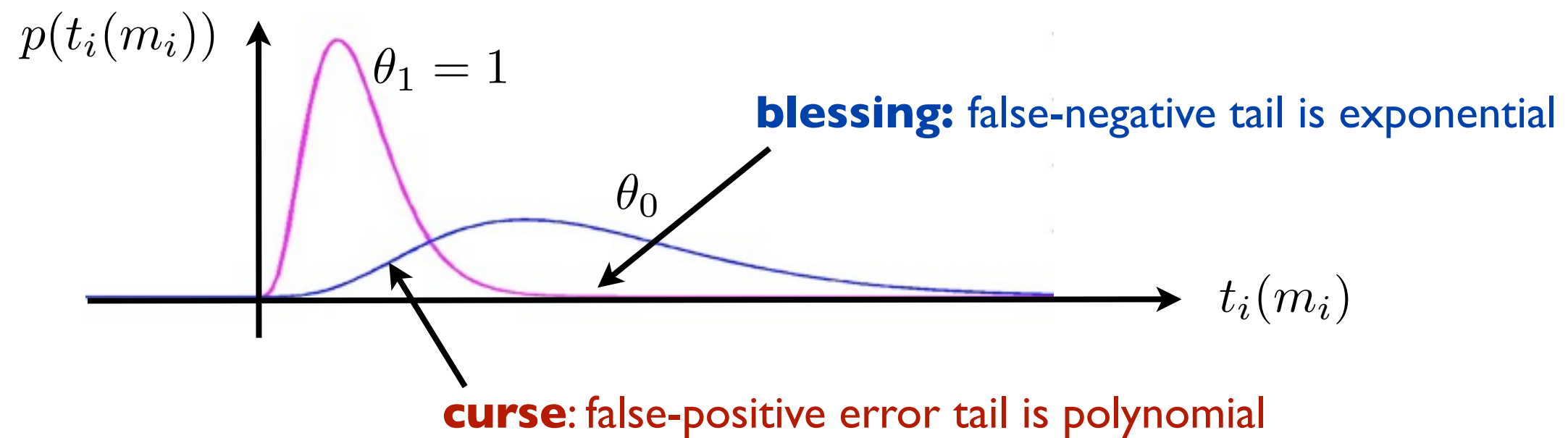


curse: false-positive error tail is polynomial

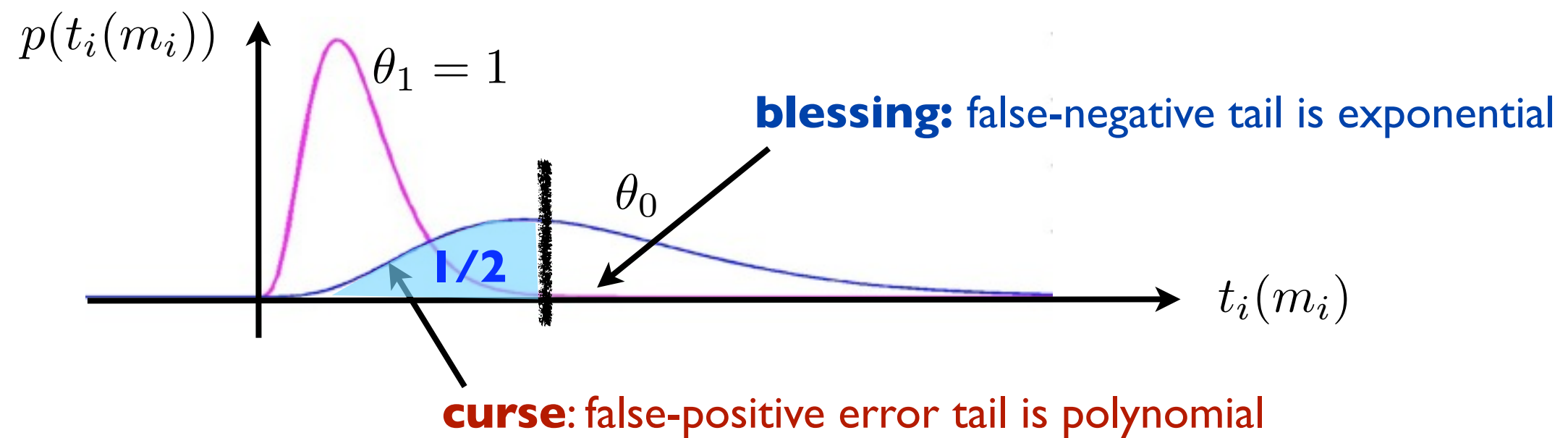
Spectrum Sensing Application



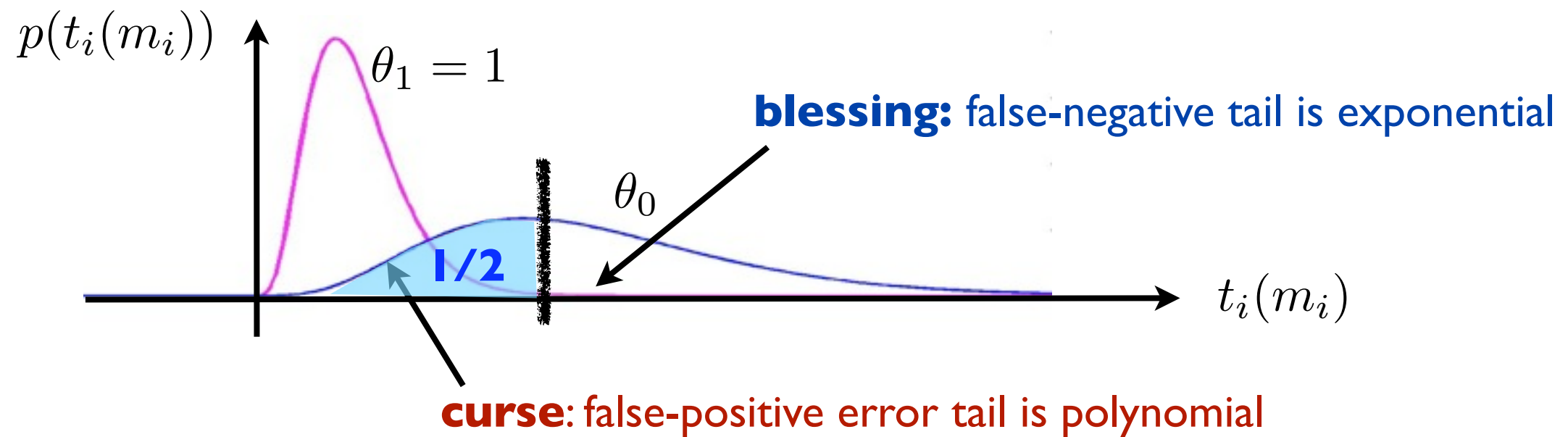
Spectrum Sensing Application



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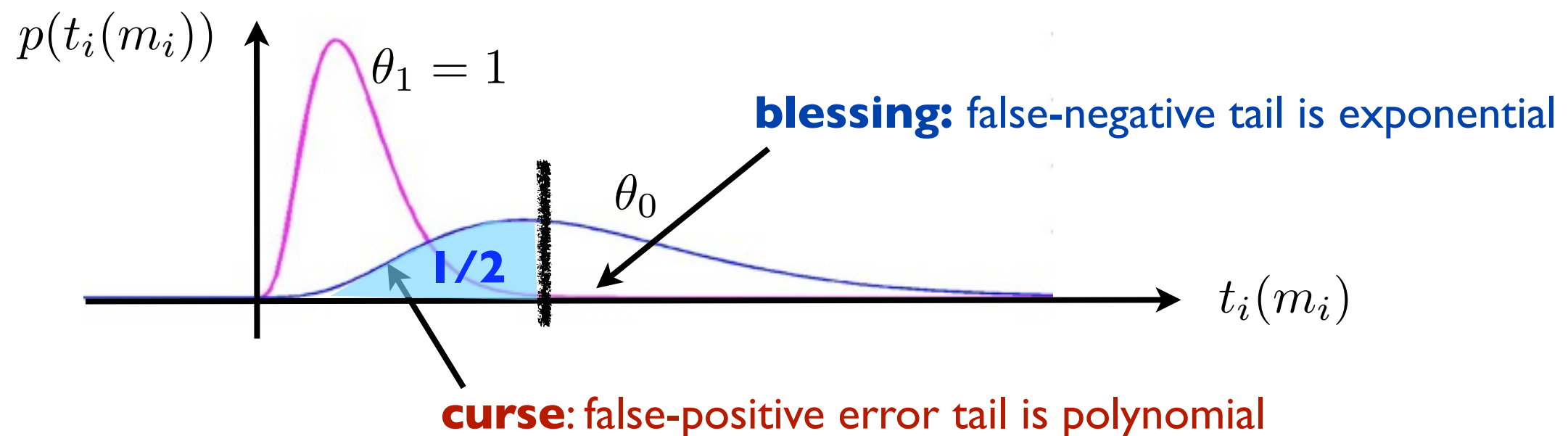


Spectrum Sensing Application



scanning budget: m = average number of samples per channel

Spectrum Sensing Application



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non-sequential: $\theta_0 > 2(m-1)(n-s)^{1/2m} \sim n^{1/2m}$ (necessary)

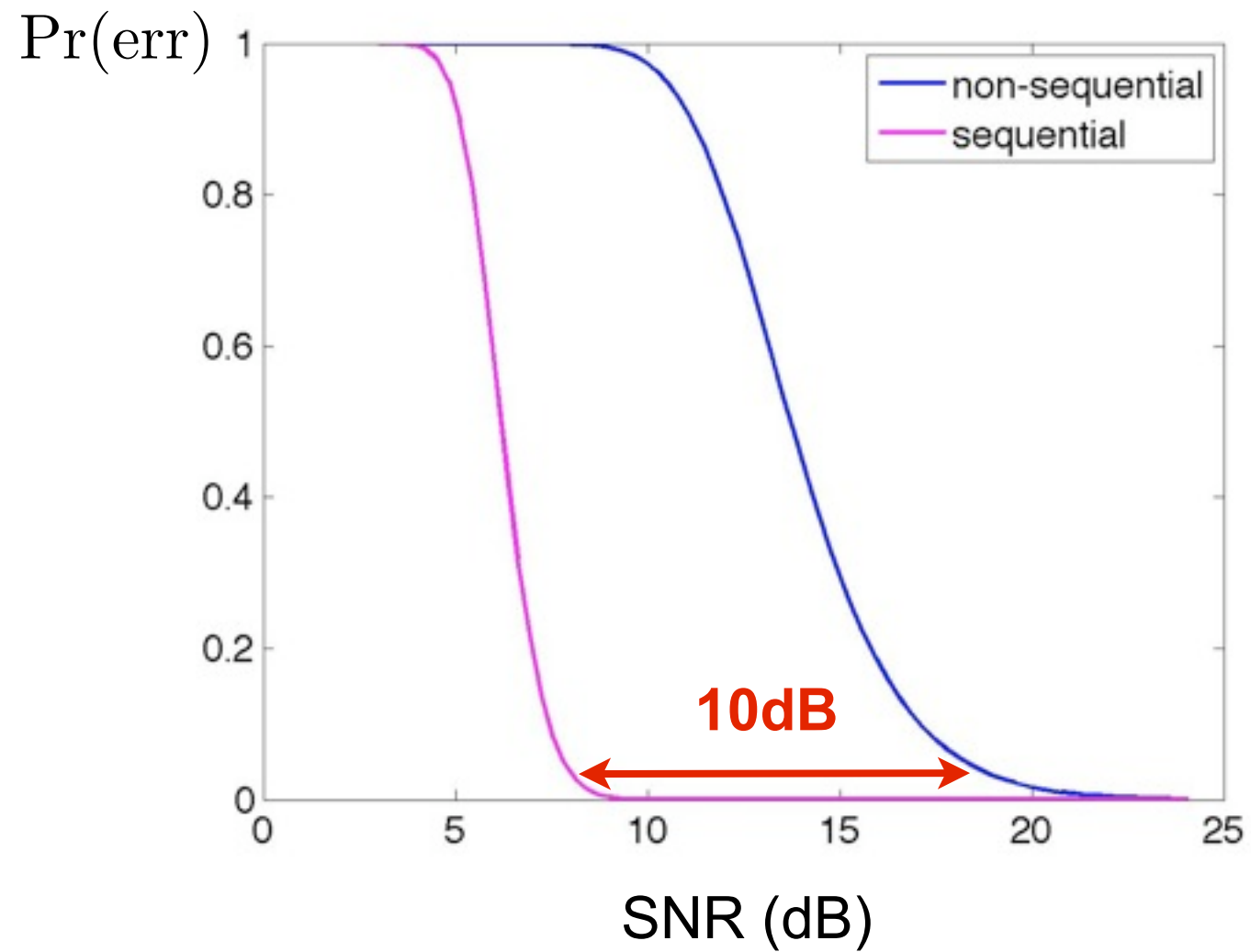
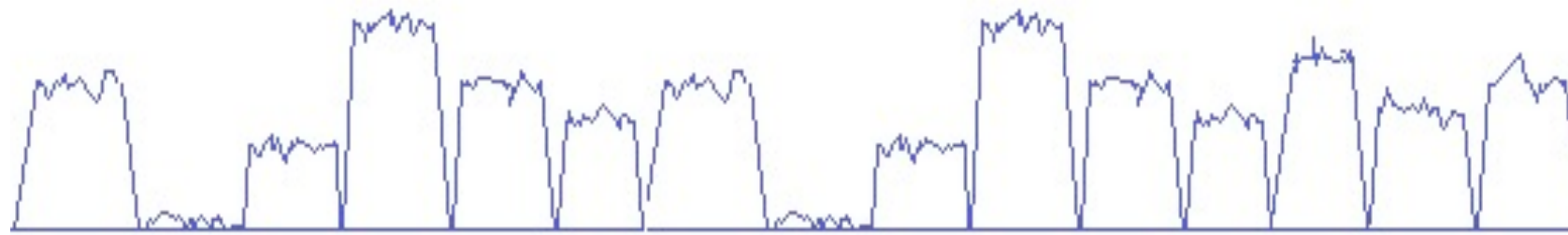
SPRT: $\theta_0 > \frac{1}{m} \log s$ minimum requirement for any testing scheme with average sample budget m

sequential thresholding: $\theta_0 > \frac{1}{m} (\log s + \log \log_2 n)$ (sufficient)

...and automatically adaptive to sparsity level

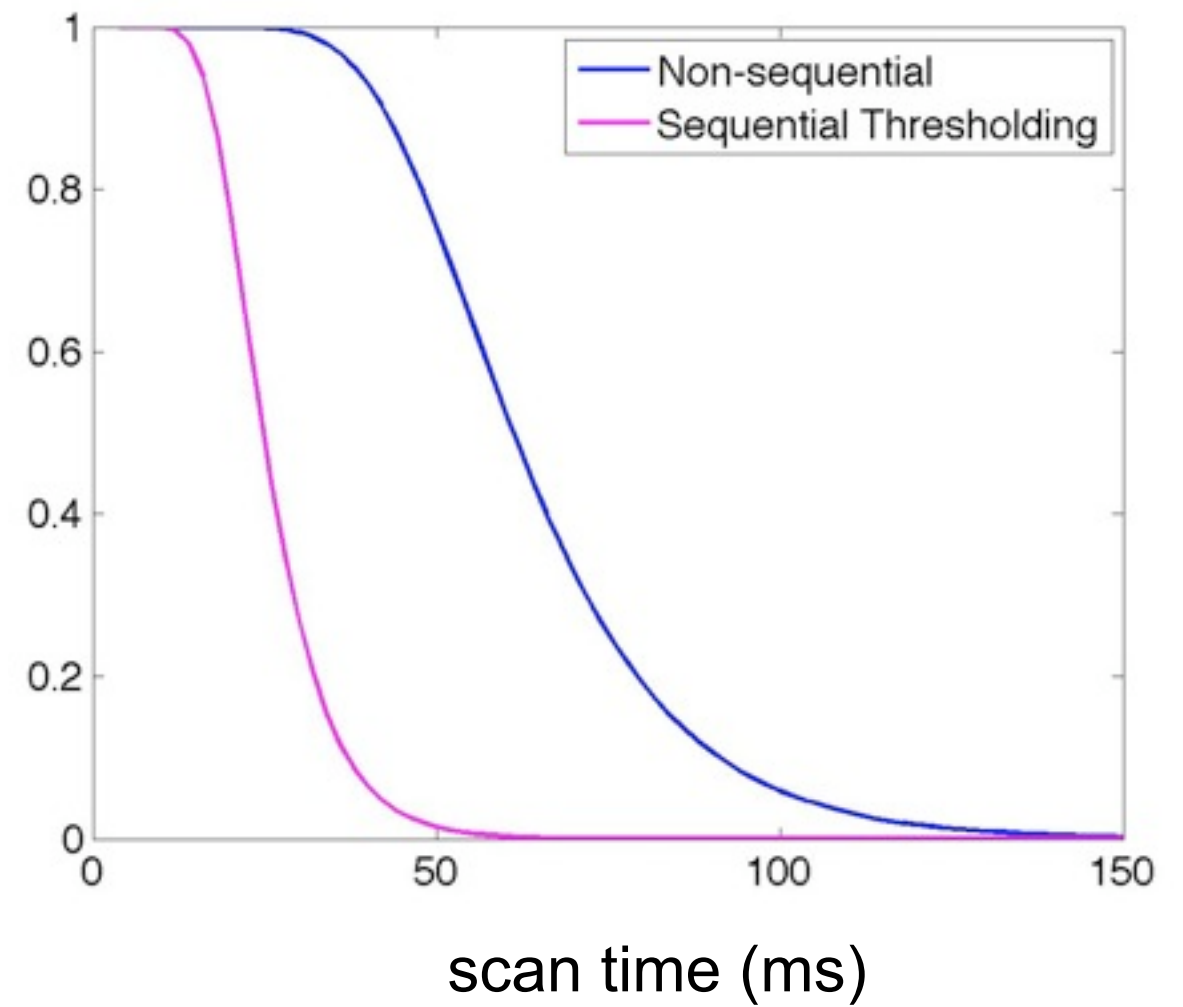
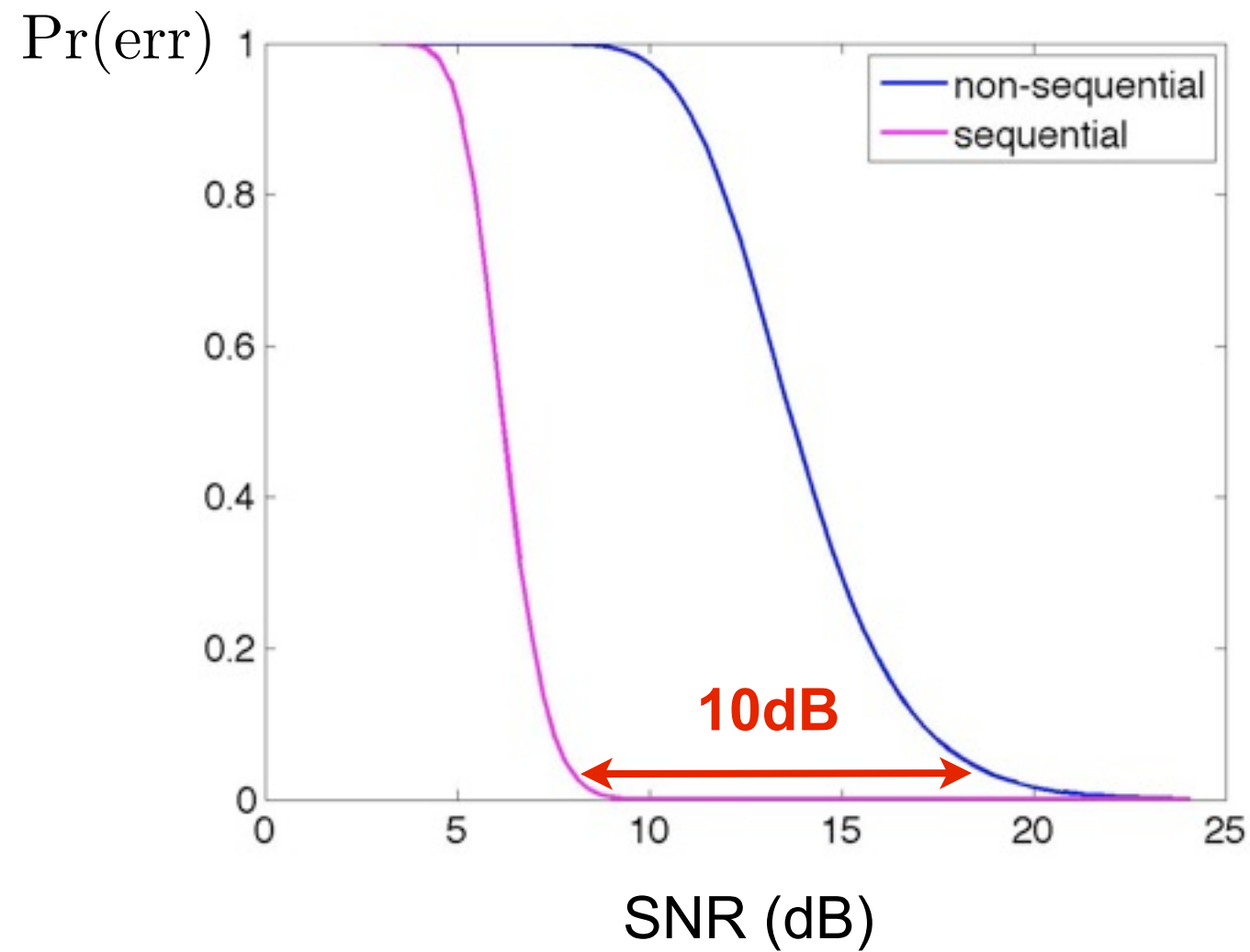
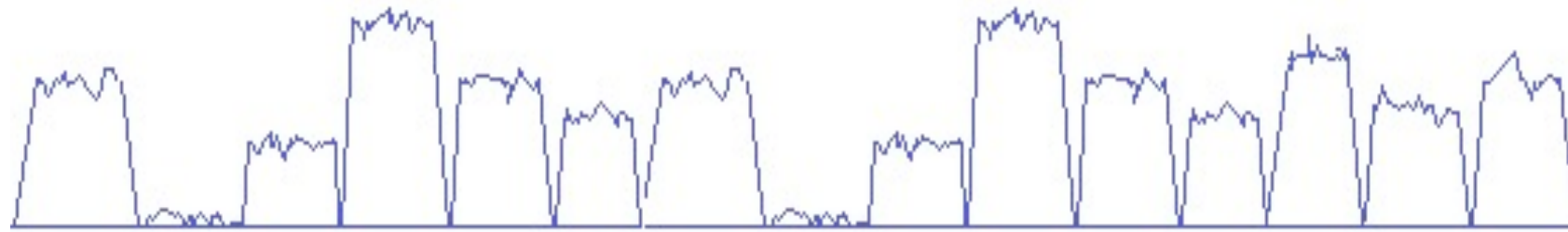
Performance

n=1000 channels, s=6 unoccupied



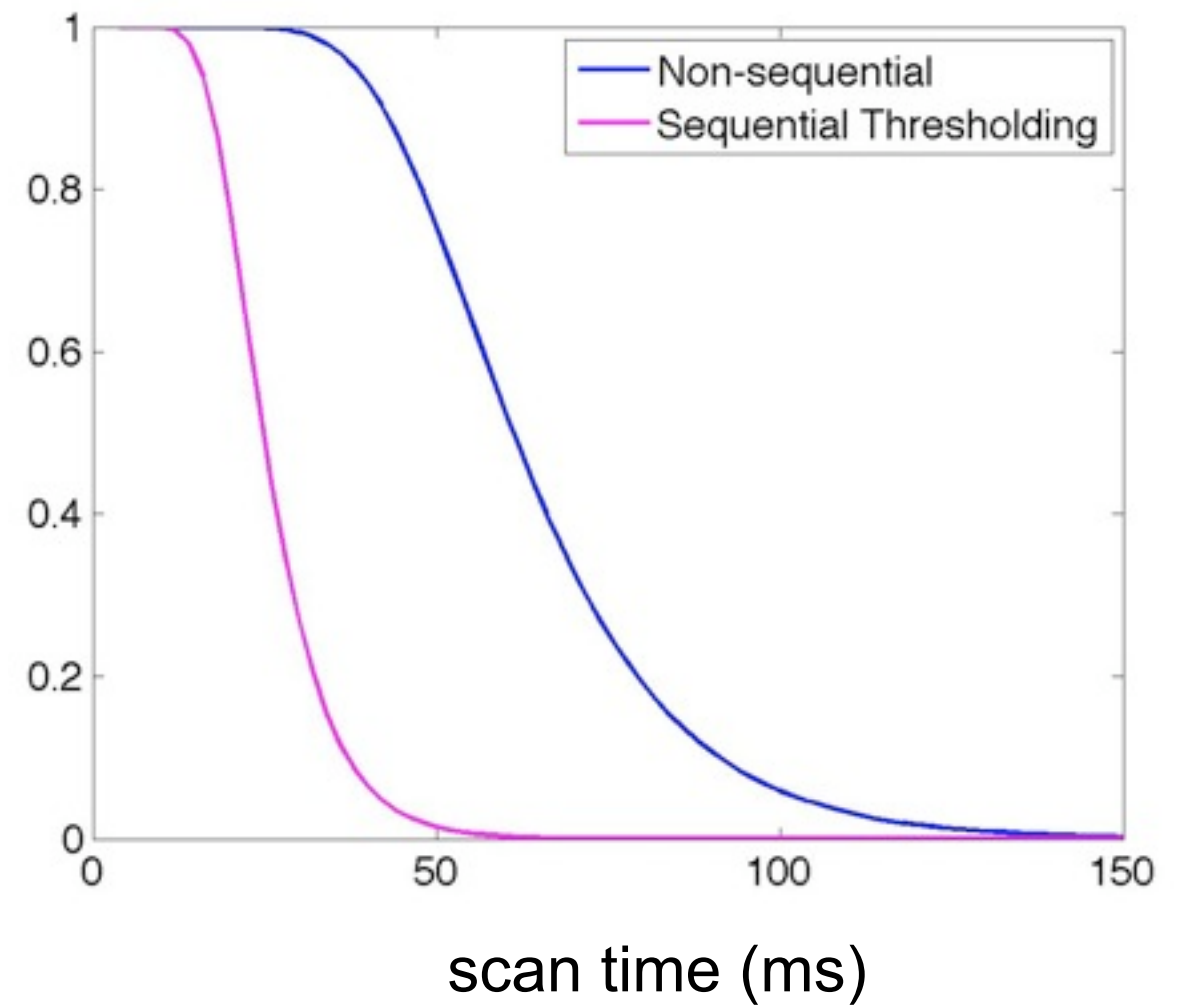
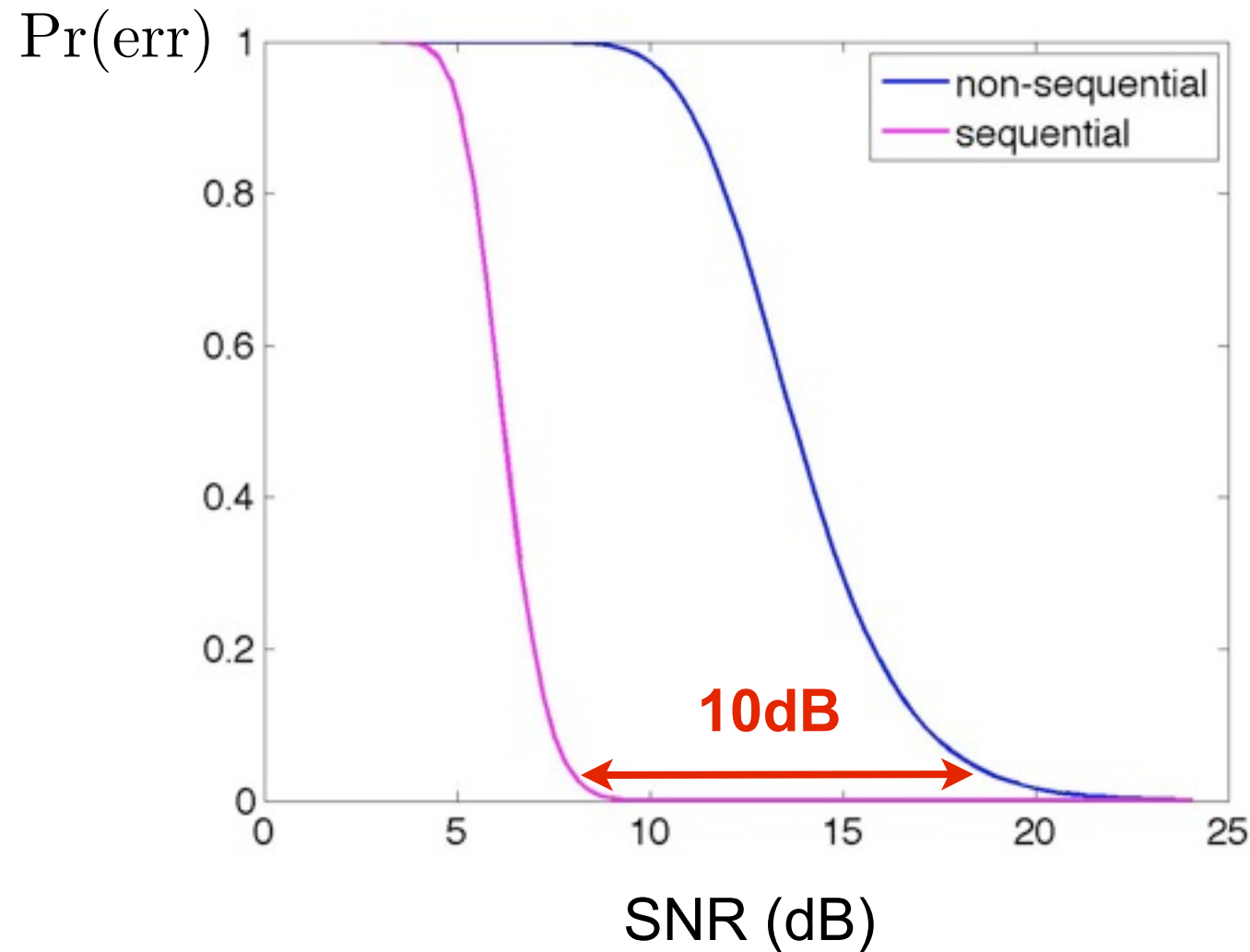
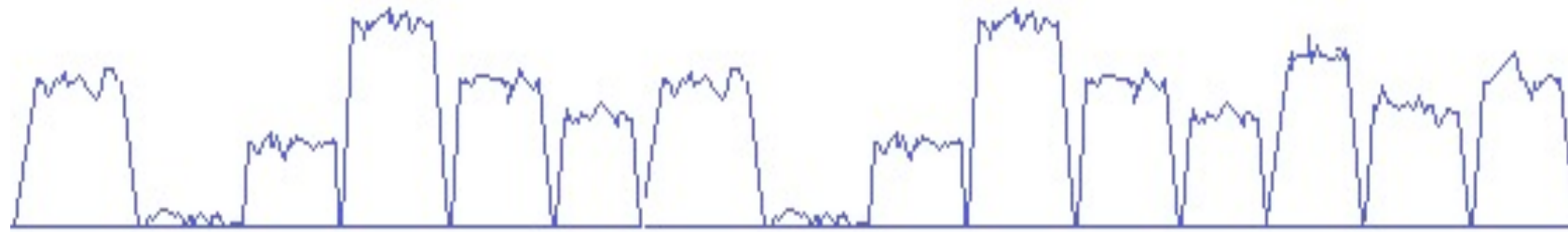
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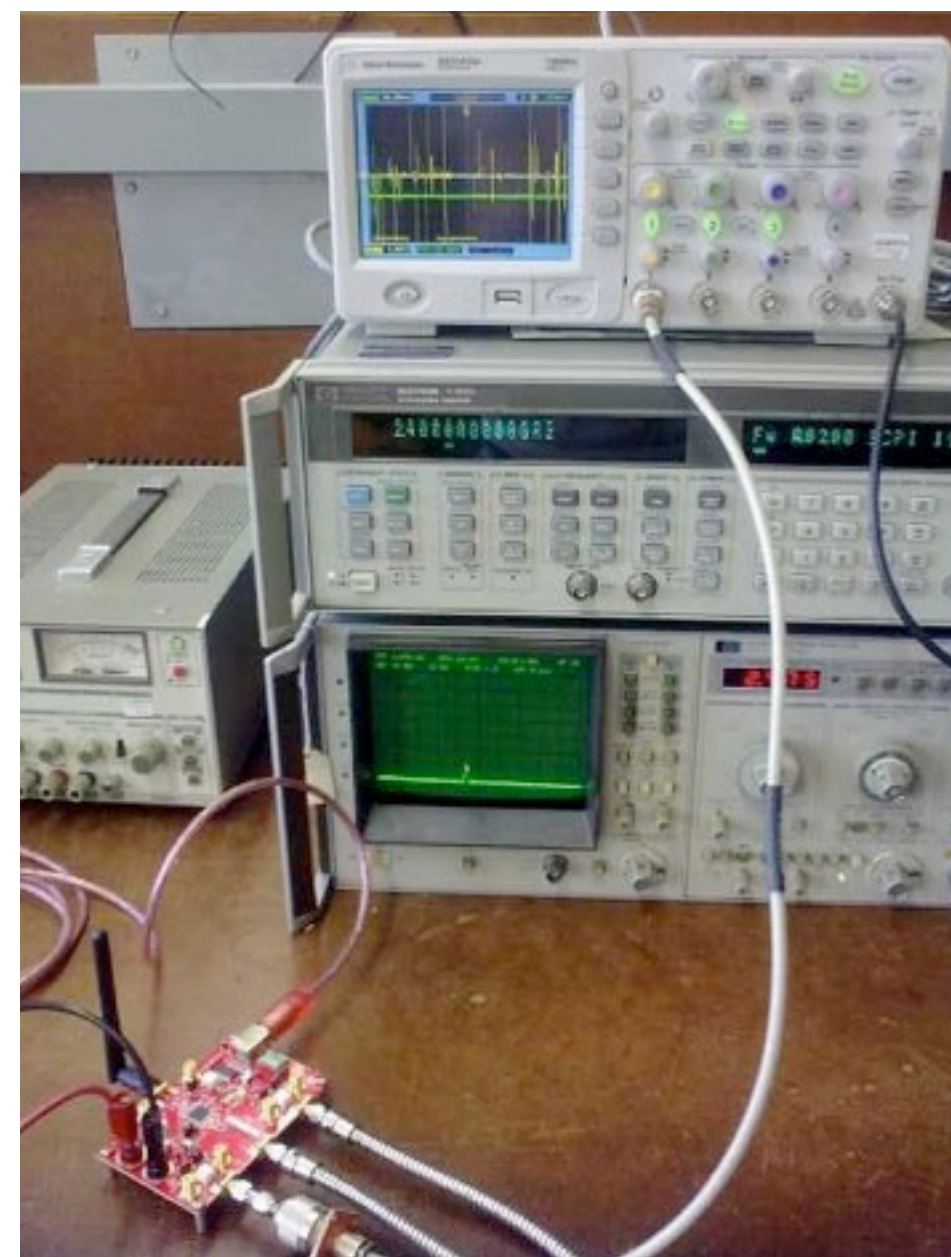


sequential thresholding is about 10 times more sensitive
(for equal scan time) or scans 3 times faster (with same reliability)

Spectrum Sensing in the Lab



Matt Malloy in the lab



Faster, Better, Stronger

requirements for reliable sequential testing in high-dimensional sparse problems:

1. $\text{SNR} \sim \max(\log(s), \log\log\log(n))$
2. total number of samples $\sim 2n$

Faster, Better, Stronger

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see Jarvis Haupt's poster

Conclusions

Sequential Experimental Designs for High-Dimensional Models

thresholds for recovery in high-dimensional limit:

non-sequential designs

$\text{SNR} \sim \log(\text{dimension})$ (or worse)

sequential designs

$\text{SNR} \sim \log(\text{sparsity level})$ (or better)

Sequential Analysis High-Dimensional Multiple Testing and Sparse Recovery
M. Malloy and RN, **arXiv:1103.5991**

Distilled Sensing: Adaptive Sampling for Sparse Detection and Estimation
J. Haupt, R. Castro, and RN, **arXiv:1001.5311v2**